

# 具有双向控制通道的 DS90UB926Q-Q1 5 至 85MHz 24 位彩色 FPD-Link III 解串器

## 1 特性

- 符合 AEC-Q100 的汽车标准应用
  - 器件温度等级 2: 环境工作温度范围为  $-40^{\circ}\text{C}$  至  $+105^{\circ}\text{C}$
  - 器件 HBM ESD 分类等级 3B
  - 器件 CDM ESD 分类等级 C6
  - 器件 MM ESD 分类等级 M3
- 具有 I<sup>2</sup>C 兼容串行控制总线的双向控制接口通道接口
- 支持高清 (720p) 数字视频格式
- 支持 RGB888 + VS、HS、DE 和同步 I2S 音频
- 支持 5 至 85MHz 像素时钟 (PCLK)
- 通过 1.8V 或 3.3V 兼容 LVCMOS I/O 接口实现 3.3V 单电源运行
- 长达 10 米的交流耦合屏蔽双绞线 (STP) 互连
- 并行 LVCMOS 视频输出
- 具有用于进行配置的 I<sup>2</sup>C 兼容串行控制总线
- 具有嵌入式时钟的直流平衡和扰频数据
- 自适应电缆均衡
- 支持中继器应用
- 全速 (@ Speed) 链路内置自检 (BIST) 模式和锁定 (LOCK) 状态引脚
- 图像增强 (白平衡和抖动) 和内部模式生成
- EMI 最小化 (展频时钟生成 (SSCG) 和增强型累进接通 (EPTO))
- 低功率模式大大减少了功率耗散
- 与 FPD-Link II 向后兼容

## 2 应用范围

- 汽车导航显示屏
- 后座娱乐系统
- 汽车驾驶辅助
- 车载百万像素级摄像机系统

## 3 说明

DS90UB926Q-Q1 解串器与 DS90UB925Q-Q1 串行器配套使用, 可提供完整的数字接口, 以便在汽车显示和图像传感应用中实现对高速视频、音频和控制数据的并行传输应用。

该芯片组将并行 RGB 视频接口转换为单对高速串行化接口。FPD-Link III 串行总线方案支持通过单条差分链路实现高速正向数据传输和低速反向通道通信的全双工控制。通过单个差分对整合视频数据和控制可减小互连线尺寸和重量, 同时还消除了偏差问题并简化了系统设计。

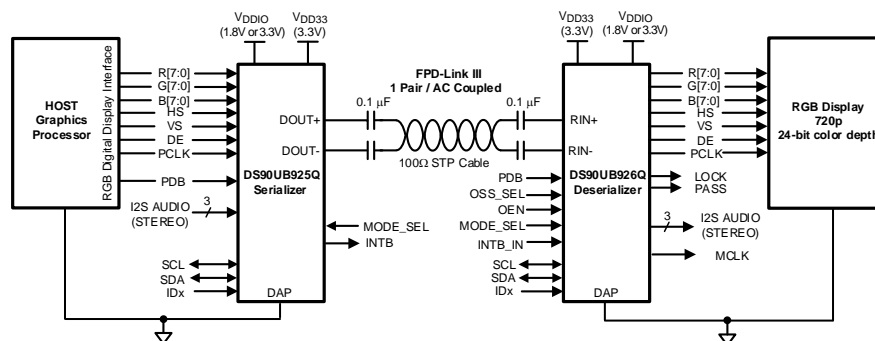
DS90UB926Q-Q1 解串器可恢复出 RGB 数据、3 个视频控制信号以及 4 个同步的 I2S 音频信号。器件会从高速串行数据流中提取出时钟。LOCK 输出引脚会在传入数据流被锁定时提供链路状态, 而无需使用训练序列或特殊的 SYNC (同步) 模式, 也不需要基准时钟。

### 器件信息<sup>(1)</sup>

器件型号	封装	封装尺寸 (标称值)
DS90UB926Q-Q1	WQFN (60)	9.00mm x 9.00mm

(1) 如需了解所有可用封装, 请参阅产品说明书末尾的可订购产品附录。

### 典型显示系统图



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## 4 修订历史记录

注：之前版本的页码可能与当前版本有所不同。

<b>Changes from Revision C (February 2017) to Revision D</b>	<b>Page</b>
• 将修订版 C 中以前所做的所有 MLCK 内容更改恢复为修订版 B .....	<b>1</b>
• Deleted the disable I2S jitter cleaner note .....	<b>6</b>

<b>Changes from Revision B (January 2015) to Revision C</b>	<b>Page</b>
• Changed pin 60 from MCLK to RES2 .....	<b>5</b>
• Changed MCLK to RES2 .....	<b>6</b>
• Added note to disable I2S jitter cleaner .....	<b>6</b>
• Changed MCLK to RES2 .....	<b>6</b>
• Deleted reference to MCLK in this section .....	<b>9</b>
• Deleted reference to MCLK in this section .....	<b>13</b>
• Deleted reference to MCLK .....	<b>28</b>
• Changed <i>MCLK</i> section .....	<b>28</b>
• Changed MCLK columns of <i>Audio Interface Frequencies</i> table .....	<b>28</b>
• Changed the values in columns 2 through 5 in Configuration Select (MODE_SEL) table .....	<b>32</b>
• Changed the values in columns 2 to 5 in Serial Control Bus Addresses for IDx table .....	<b>35</b>
• Changed register reference to MCLK .....	<b>45</b>
• Changed Typical Display System Diagram (removed reference to MCLK) .....	<b>49</b>
• Changed wording of <i>Power Up Requirements and PDB Pin</i> subsection and added Power-Up Sequence graphic .....	<b>51</b>

**Changes from Revision A (April 2013) to Revision B**
**Page**

- 已添加 添加了引脚配置和功能 部分、ESD 额定值表、特性说明 部分、器件功能模式、应用和实施 部分、电源相关建议 部分、布局 部分、器件和文档支持 部分以及机械、封装和可订购信息 部分 ..... **1**

**Changes from Original (July 2012) to Revision A**
**Page**

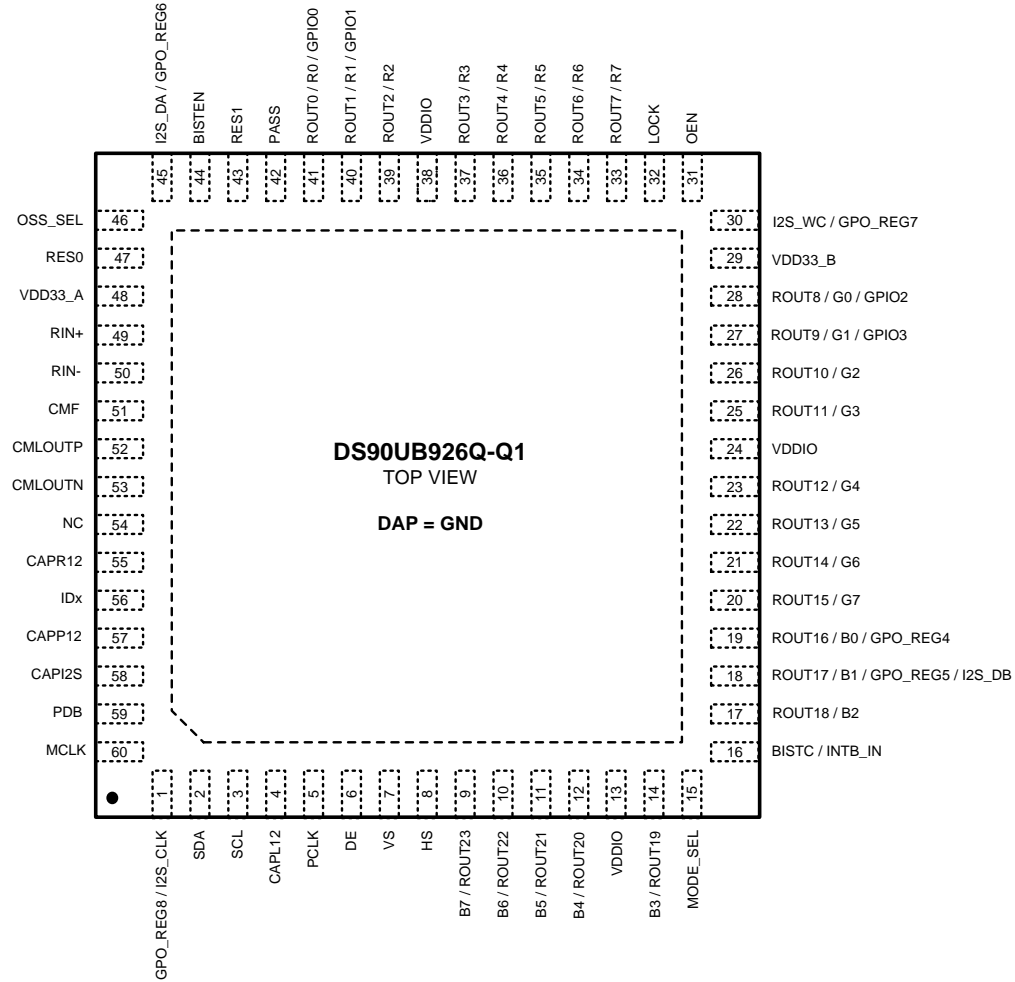
- 将“直流和交流串行控制总线特性”表中的拼写错误从 VDDIO 更正为 VDD33，添加了“注：BIST 在向后兼容模式下不可用。”，添加了“推荐 FRC 设置”表，更改了数据表的整体布局以符合 TI 格式，向“绝对最大额定值”部分添加了注 (3)：在切换至掉电状态的过程中（PDB 从高电平切换至低电平），上限值 ( $V_{DDIO} + 0.3V$ ) 不适用于 PDB 引脚，删除了 25°C 下最大功耗量的降额。 ..... **4**
- "Note: BIST is not available in backwards compatible mode." ..... **26**

## 5 说明（续）

DS90UB926Q-Q1 解串器具有一个 31 位并行 LVCMOS 输出接口，可针对 RGB、视频控制和音频数据进行调整。自适应均衡器优化了最大电缆长度。输出扩频时钟发生器 (SSCG) 和增强型渐进接通 (EPTO) 功能大大降低了电磁干扰 (EMI) 特性。

## 6 Pin Configuration and Functions

**NKB Package**  
**60-Pin WQFN With Exposed Thermal Pad**  
**Top View**



### Pin Functions

PIN		I/O, TYPE	DESCRIPTION
NAME	NO.		
<b>LVCNMOS PARALLEL INTERFACE</b>			
ROUT[23:0] / R[7:0], G[7:0], B[7:0]	41, 40, 39, 37, 36, 35, 34, 33, 28, 27, 26, 25, 23, 22, 21, 20, 19, 18, 17, 14, 12, 11, 10, 9	O, LVCNMOS with pulldown	Parallel Interface Data Output Pins Leave open if unused. ROUT0 / R0 can optionally be used as GPIO0 and ROUT1 / R1 can optionally be used as GPIO1. ROUT8 / G0 can optionally be used as GPIO2 and ROUT9 / G1 can optionally be used as GPIO3. ROUT16 / B0 can optionally be used as GPO_REG4 and ROUT17/ B1 can optionally be used as I2S_DB / GPO_REG5.
HS	8	O, LVCNMOS with pulldown	Horizontal Sync Output Pin Video control signal pulse width must be 3 PCLKs or longer to be transmitted when the Control Signal Filter is enabled. There is no restriction on the minimum transition pulse when the Control Signal Filter is disabled. The signal is limited to 2 transitions per 130 PCLKs. See <a href="#">Table 11</a>
VS	7	O, LVCNMOS with pulldown	Vertical Sync Output Pin Video control signal is limited to 1 transition per 130 PCLKs. Thus, the minimum pulse width is 130 PCLKs.
DE	6	O, LVCNMOS with pulldown	Data Enable Output Pin Video control signal pulse width must be 3 PCLKs or longer to be transmitted when the Control Signal Filter is enabled. There is no restriction on the minimum transition pulse when the Control Signal Filter is disabled. The signal is limited to 2 transitions per 130 PCLKs. See <a href="#">Table 11</a>
PCLK	5	O, LVCNMOS with pulldown	Pixel Clock Output Pin. Strobe edge set by RFB configuration register. See <a href="#">Table 11</a>
I2S_CLK, I2S_WC, I2S_DA	1, 30, 45	O, LVCNMOS with pulldown	Digital Audio Interface Data Output Pins Leave open if unused I2S_CLK can optionally be used as GPO_REG8, I2S_WC can optionally be used as GPO_REG7, and I2S_DA can optionally be used as GPO_REG6.
MCLK	60	O, LVCNMOS with pulldown	I2S Master Clock Output x1, x2, or x4 of I2S_CLK Frequency
<b>OPTIONAL PARALLEL INTERFACE</b>			
I2S_DB	18	O, LVCNMOS with pulldown	Second Channel Digital Audio Interface Data Output pin at 18-bit color mode and set by MODE_SEL or configuration register Leave open if unused I2S_B can optionally be used as BI or GPO_REG5.
GPIO[3:0]	27, 28, 40, 41	I/O, LVCNMOS with pulldown	Standard General Purpose IOs. Available only in 18-bit color mode, and set by MODE_SEL or configuration register. See <a href="#">Table 11</a> Leave open if unused Shared with G1, G0, R1 and R0.
GPO_REG[8: 4]	1, 30, 45, 18, 19	O, LVCNMOS with pulldown	General Purpose Outputs and set by configuration register. See <a href="#">Table 11</a> Shared with I2S_CLK, I2S_WC, I2S_DA, I2S_DB or B1, B0.
INTB_IN	16	Input, LVCNMOS with pulldown	Interrupt Input Shared with BISTC
<b>OPTIONAL PARALLEL INTERFACE</b>			
PDB	59	I, LVCNMOS with pulldown	Power-down Mode Input Pin PDB = H, device is enabled (normal operation) Refer to <a href="#">Power Up Requirements and PDB Pin</a> . PDB = L, device is powered down. When the device is in the POWER DOWN state, the LVCNMOS Outputs are in TRI-STATE, the PLL is shutdown and IDD is minimized. .
OEN	31	Input, LVCNMOS with pulldown	Output Enable Pin See <a href="#">Table 8</a>
OSS_SEL	46	Input, LVCNMOS with pulldown	Output Sleep State Select Pin See <a href="#">Table 8</a>

**Pin Functions (continued)**

PIN		I/O, TYPE	DESCRIPTION
NAME	NO.		
MODE_SEL	15	I, Analog	Device Configuration Select. See <a href="#">Table 9</a>
IDx	56	I, Analog	I2C Serial Control Bus Device ID Address Select External pullup to V <sub>DD33</sub> is required under all conditions, DO NOT FLOAT. Connect to external pullup and pulldown resistor to create a voltage divider. See <a href="#">Figure 23</a>
SCL	3	I/O, LVCMOS Open-Drain	I2C Clock Input / Output Interface Must have an external pullup to V <sub>DD33</sub> , DO NOT FLOAT. Recommended pullup: 4.7 k $\Omega$ .
SDA	2	I/O, LVCMOS Open-Drain	I2C Data Input / Output Interface Must have an external pullup to V <sub>DD33</sub> , DO NOT FLOAT. Recommended pullup: 4.7 k $\Omega$ .
BISTEN	44	I, LVCMOS with pulldown	BIST Enable Pin 0: BIST Mode is disabled. 1: BIST Mode is enabled.
BISTC	16	I, LVCMOS with pulldown	BIST Clock Select Shared with INTB_IN 0: PCLK; 1: 33 MHz
<b>STATUS</b>			
LOCK	32	O, LVCMOS with pulldown	LOCK Status Output Pin 0: PLL is unlocked, ROUT[23:0]/RGB[7:0], I2S[2:0], HS, VS, DE and PCLK output states are controlled by OEN. May be used as Link Status or Display Enable 1: PLL is Locked, outputs are active
PASS	42	O, LVCMOS with pulldown	PASS Output Pin 0: One or more errors were detected in the received payload 1: ERROR FREE Transmission Leave Open if unused. Route to test point (pad) recommended
<b>FPD-LINK III SERIAL INTERFACE</b>			
RIN+	49	I, LVDS	True Input. The interconnection should be AC-coupled to this pin with a 0.1- $\mu$ F capacitor.
RIN-	50	I, LVDS	Inverting Input. The interconnection should be AC-coupled to this pin with a 0.1- $\mu$ F capacitor.
CMLOUTP	52	O, LVDS	True CML Output Monitor point for equalized differential signal
CMLOUTN	53	O, LVDS	Inverting CML Output Monitor point for equalized differential signal
CMF	51	Analog	Common Mode Filter. Connect 0.1- $\mu$ F capacitor to GND
<b>POWER AND GROUND<sup>(1)</sup></b>			
VDD33_A, VDD33_B	48, 29	Power	Power to on-chip regulator <b>3 V – 3.6 V</b> . Requires 4.7 $\mu$ F to GND at each VDD pin.
VDDIO	13, 24, 38	Power	LVCMOS I/O Power <b>1.8 V <math>\pm</math>5% OR 3 V – 3.6 V</b> . Requires 4.7 $\mu$ F to GND at each VDDIO pin.
GND	DAP	Ground	DAP is the large metal contact at the bottom side, located at the center of the WQFN package. <b>Connect to the ground plane (GND)</b> with at least 9 vias.
<b>REGULATOR CAPACITOR</b>			
CAPR12, CAPP12, CAPI2S	55, 57, 58	CAP	Decoupling capacitor connection for on-chip regulator. Requires a 4.7 $\mu$ F to GND at each CAP pin.
CAPL12	4	CAP	Decoupling capacitor connection for on-chip regulator. Requires two 4.7 $\mu$ F to GND at this CAP pin.
<b>OTHERS</b>			
NC	54	NC	No connect. This pin may be left open or tied to any level.
RES[1:0]	43,47	GND	Reserved - tie to Ground.

(1) The VDD (V<sub>DD33</sub> and V<sub>DDIO</sub>) supply ramp must be faster than 1.5 ms with a monotonic rise.

## 7 Specifications

### 7.1 Absolute Maximum Ratings

See <sup>(1)</sup>(<sup>2</sup>)(<sup>3</sup>)(<sup>4</sup>)

		MIN	MAX	UNIT
Supply voltage – $V_{DD33}$		-0.3	4	V
Supply voltage – $V_{DDIO}$		-0.3	4	V
LVCMOS I/O voltage		-0.3	( $V_{DDIO} + 0.3$ )	V
Deserializer input voltage		-0.3	2.75	V
Junction temperature			150	°C
Maximum power dissipation capacity at 25°C	$R_{\theta JA}$		31	°C/W
	$R_{\theta JC}$		2.4	°C/W
Storage temperature, $T_{stg}$		-65	150	°C

- Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions*. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- If Military/Aerospace specified devices are required, contact the Texas Instruments Sales Office/ Distributors for availability and specifications.
- The maximum limit ( $V_{DDIO} + 0.3$  V) does not apply to the PDB pin during the transition to the power down state (PDB transitioning from HIGH to LOW).
- For soldering specifications: see product folder at [www.ti.com](http://www.ti.com) and *Absolute Maximum Ratings for Soldering* (SNOA549).

### 7.2 ESD Ratings

		VALUE	UNIT	
$V_{(ESD)}$ Electrostatic discharge	Human-body model (HBM), per AEC Q100-002 <sup>(1)</sup>	±8000	V	
	Charged-device model (CDM), per AEC Q100-011	±1250		
	Machine model	±250		
	(IEC, powered-up only) $R_D = 330 \Omega$ , $C_S = 150$ pF	Air Discharge (Pin 49 and 50)		±15000
		Contact Discharge (Pin 49 and 50)		±8000
	(ISO1060SN5), $R_D = 330 \Omega$ $C_S = 150$ pF	Air Discharge (Pin 49 and 50)		±15000
		Contact Discharge (Pin 49 and 50)		±8000
	(ISO10605), $R_D = 2$ k $\Omega$ $C_S = 150$ and 330 pF	Air Discharge (Pin 49 and 50)		±15000
Contact Discharge (Pin 49 and 50)		±8000		

- AEC Q100-002 indicates that HBM stressing shall be in accordance with the ANSI/ESDA/JEDEC JS-001 specification.

### 7.3 Recommended Operating Conditions

		MIN	NOM	MAX	UNIT
Supply voltage ( $V_{DD33}$ )		3	3.3	3.6	V
LVCMOS supply voltage ( $V_{DDIO}$ )	Connect $V_{DDIO}$ to 3.3 V and use 3.3-V IOs	3	3.3	3.6	V
	Connect $V_{DDIO}$ to 1.8 V and use 1.8-V IOs	1.71	1.8	1.89	V
Operating free air temperature ( $T_A$ )		-40	25	105	°C
PCLK frequency		5		85	MHz
Supply noise <sup>(1)</sup>				100	mV <sub>P-P</sub>

- Supply noise testing was done with minimum capacitors on the PCB. A sinusoidal signal is AC-coupled to the  $V_{DD33}$  and  $V_{DDIO}$  supplies with amplitude = 100 mV<sub>P-P</sub> measured at the device  $V_{DD33}$  and  $V_{DDIO}$  pins. Bit error rate testing of input to the Ser and output of the Des with 10 meter cable shows no error when the noise frequency on the Ser is less than 50 MHz. The Des on the other hand shows no error when the noise frequency is less than 50 MHz.

## 7.4 Thermal Information

THERMAL METRIC <sup>(1)</sup>		DS90UB926Q-Q1	UNIT
		NKB (WQFN)	
		60 PINS	
R <sub>θJA</sub>	Junction-to-ambient thermal resistance	26.2	°C/W
R <sub>θJC(top)</sub>	Junction-to-case (top) thermal resistance	8.1	°C/W
R <sub>θJB</sub>	Junction-to-board thermal resistance	5.2	°C/W
ψ <sub>JT</sub>	Junction-to-top characterization parameter	0.1	°C/W
ψ <sub>JB</sub>	Junction-to-board characterization parameter	5.2	°C/W
R <sub>θJC(bot)</sub>	Junction-to-case (bottom) thermal resistance	1.1	°C/W

(1) For more information about traditional and new thermal metrics, see [Semiconductor and IC Package Thermal Metrics](#).

## 7.5 DC Electrical Characteristics

over recommended operating supply and temperature ranges unless otherwise specified.<sup>(1) (2) (3)</sup>

PARAMETER	TEST CONDITIONS	PIN/FREQ.	MIN	TYP	MAX	UNIT	
<b>LVC MOS I/O DC SPECIFICATIONS</b>							
V <sub>IH</sub>	High Level Voltage	V <sub>DDIO</sub> = 3 to 3.6 V	2		V <sub>DDIO</sub>	V	
V <sub>IL</sub>	Low Level Input	V <sub>DDIO</sub> = 3 to 3.6 V	GND		0.8	V	
I <sub>IN</sub>	Input Current	V <sub>IN</sub> = 0 V or V <sub>DDIO</sub> = 3 to 3.6 V	-10	±1	10	μA	
V <sub>IH</sub>	High Level Input Voltage	V <sub>DDIO</sub> = 3 to 3.6 V	2		V <sub>DDIO</sub>	V	
		V <sub>DDIO</sub> = 1.71 to 1.89 V	0.65 × V <sub>DDIO</sub>		V <sub>DDIO</sub>		
V <sub>IL</sub>	Low Level Input Voltage	V <sub>DDIO</sub> = 3 to 3.6 V	GND		0.8	V	
		V <sub>DDIO</sub> = 1.71 to 1.89 V	GND		0.35 × V <sub>DDIO</sub>		
I <sub>IN</sub>	Input Current	V <sub>IN</sub> = 0 V or V <sub>DDIO</sub>	V <sub>DDIO</sub> = 3 to 3.6 V	-10	±1	10	μA
			V <sub>DDIO</sub> = 1.7 to 1.89 V	-10	±1	10	
V <sub>OH</sub>	High Level Output Voltage	I <sub>OH</sub> = -4 mA	V <sub>DDIO</sub> = 3 to 3.6 V	2.4		V <sub>DDIO</sub>	V
			V <sub>DDIO</sub> = 1.7 to 1.89 V	V <sub>DDIO</sub> - 0.45		V <sub>DDIO</sub>	
V <sub>OL</sub>	Low Level Output Voltage	I <sub>OL</sub> = 4 mA	V <sub>DDIO</sub> = 3 to 3.6 V	GND		0.4	V
			V <sub>DDIO</sub> = 1.7 to 1.89 V	GND		0.35	
I <sub>OS</sub>	Output Short Circuit Current	V <sub>OUT</sub> = 0 V		-60		mA	
I <sub>OZ</sub>	Tri-state Output Current	V <sub>OUT</sub> = 0 V or V <sub>DDIO</sub> , PDB = L	-10		10	μA	

- The *Electrical Characteristics* tables list ensured specifications under the listed [Recommended Operating Conditions](#) except as otherwise modified or specified by the Electrical Characteristics Conditions and/or Notes. Typical specifications are estimations only and are not ensured.
- Typical values represent most likely parametric norms at V<sub>DD</sub> = 3.3 V, T<sub>A</sub> = 25°C, and at the [Recommended Operating Conditions](#) at the time of product characterization and are not ensured.
- Current into device pins is defined as positive. Current out of a device pin is defined as negative. Voltages are referenced to ground except V<sub>OD</sub> and ΔV<sub>OD</sub>, which are differential voltages.

**DC Electrical Characteristics (continued)**

 over recommended operating supply and temperature ranges unless otherwise specified.<sup>(1) (2) (3)</sup>

PARAMETER		TEST CONDITIONS		PIN/FREQ.	MIN	TYP	MAX	UNIT		
<b>FPD-LINK III CML RECEIVER INPUT DC SPECIFICATIONS</b>										
$V_{TH}$	Differential Threshold High Voltage	$V_{CM} = 2.5\text{ V}$ (Internal $V_{BIAS}$ )		RIN+, RIN-			50	mV		
$V_{TL}$	Differential Threshold Low Voltage						-50		mV	
$V_{CM}$	Differential Common-mode Voltage							1.8		V
$R_T$	Internal Termination Resistor - Differential						80	100	120	$\Omega$
<b>CML MONITOR DRIVER OUTPUT DC SPECIFICATIONS</b>										
$V_{ODp-p}$	Differential Output Voltage	$R_L = 100\ \Omega$		CMLOUTP, CMLOUTN	360			mVp-p		
<b>SUPPLY CURRENT</b>										
$I_{DD1}$	Supply Current (includes load current) $f = 85\text{ MHz}$	$C_L = 12\text{ pF}$ , Checker Board Pattern (Figure 1)	$V_{DD33} = 3.6\text{ V}$	$V_{DD33}$		125	145	mA		
$I_{DDIO1}$			$V_{DDIO} = 3.6\text{ V}$	$V_{DDIO}$		110	118		mA	
			$V_{DDIO} = 1.89\text{ V}$	$V_{DDIO}$		60	75			
$I_{DD2}$	Supply Current (includes load current) $f = 85\text{ MHz}$	$C_L = 4\text{ pF}$ Checker Board Pattern (Figure 1)	$V_{DD33} = 3.6\text{ V}$	$V_{DD33}$		125	145	mA		
$I_{DDIO2}$			$V_{DDIO} = 3.6\text{ V}$	$V_{DDIO}$		75	85		mA	
			$V_{DDIO} = 1.89\text{ V}$	$V_{DDIO}$		50	65			
$I_{DDS}$	Supply Current Sleep Mode	Without Input Serial Stream	$V_{DD33} = 3.6\text{ V}$	$V_{DD33}$		90	115	mA		
$I_{DDIOS}$			$V_{DDIO} = 3.6\text{ V}$	$V_{DDIO}$		3	5		mA	
			$V_{DDIO} = 1.89\text{ V}$	$V_{DDIO}$		2	3			
$I_{DDZ}$	Supply Current Power Down	PDB = L, All LVCMOS inputs are floating or tied to GND	$V_{DD33} = 3.6\text{ V}$	$V_{DD33}$		2	10	mA		
$I_{DDIOZ}$			$V_{DDIO} = 3.6\text{ V}$	$V_{DDIO}$		0.05	10		mA	
			$V_{DDIO} = 1.89\text{ V}$	$V_{DDIO}$		0.05	10			

## 7.6 AC Electrical Characteristics

Over recommended operating supply and temperature ranges unless otherwise specified. <sup>(1)</sup> <sup>(2)</sup> <sup>(3)</sup>

PARAMETER		TEST CONDITIONS	PIN/FREQ.	MIN	TYP	MAX	UNIT
<b>GPIO BIT RATE</b>							
B <sub>R</sub>	Forward Channel Bit Rate	See <sup>(4)</sup> <sup>(5)</sup>	f = 5 to 85 MHz, GPIO[3:0]	0.25 × f			Mbps
	Back Channel Bit Rate			>50	>75		kbps
<b>CML MONITOR DRIVER OUTPUT AC SPECIFICATIONS</b>							
E <sub>W</sub>	Differential Output Eye Opening Width <sup>(6)</sup>	R <sub>L</sub> = 100 Ω, Jitter Freq > f / 40 (Figure 2) <sup>(4)</sup> <sup>(5)</sup>	CMLOUTP, CMLOUTN, f = 85 MHz	0.3	0.4		UI
E <sub>H</sub>	Differential Output Eye Height			200	300		mV
<b>BIST MODE</b>							
t <sub>PASS</sub>	BIST PASS Valid Time BISTEN = H (Figure 8) <sup>(4)</sup> <sup>(5)</sup>		PASS	800			ns
<b>SSCG MODE</b>							
f <sub>DEV</sub>	Spread Spectrum Clocking Deviation Frequency	See Figure 14, Table 1, Table 2 <sup>(4)</sup> <sup>(5)</sup>	f = 85 MHz, SSCG = ON	±0.5%		±2.5%	
f <sub>MOD</sub>	Spread Spectrum Clocking Modulation Frequency			8	100		kHz

- (1) The *Electrical Characteristics* tables list ensured specifications under the listed in *Recommended Operating Conditions* except as otherwise modified or specified by the Electrical Characteristics Conditions and/or Notes. Typical specifications are estimations only and are not ensured.
- (2) Typical values represent most likely parametric norms at V<sub>DD</sub> = 3.3 V, T<sub>A</sub> = 25 °C, and at the *Recommended Operating Conditions* at the time of product characterization and are not ensured.
- (3) Current into device pins is defined as positive. Current out of a device pin is defined as negative. Voltages are referenced to ground except V<sub>OD</sub> and ΔV<sub>OD</sub>, which are differential voltages.
- (4) Specification is ensured by characterization and is not tested in production.
- (5) Specification is ensured by design and is not tested in production.
- (6) UI – Unit Interval is equivalent to one serialized data bit width (1UI = 1 / 35 \* PCLK). The UI scales with PCLK frequency.

## 7.7 DC and AC Serial Control Bus Characteristics

 Over 3.3-V supply and temperature ranges unless otherwise specified. <sup>(1)</sup> <sup>(2)</sup> <sup>(3)</sup>

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
V <sub>IH</sub>	Input High Level	SDA and SCL	0.7 × V <sub>DD33</sub>		V <sub>DD33</sub>	V
V <sub>IL</sub>	Input Low Level Voltage	SDA and SCL	GND		0.3 × V <sub>DD33</sub>	V
V <sub>HY</sub>	Input Hysteresis			> 50		mV
V <sub>OL</sub>		SDA, IOL = 1.25 mA	0		0.36	V
I <sub>in</sub>		SDA or SCL, V <sub>IN</sub> = V <sub>DD33</sub> or GND	-10		10	μA
t <sub>R</sub>	SDA RiseTime – READ	SDA, RPU = 10 kΩ, C <sub>b</sub> ≤ 400 pF (Figure 9)		430		ns
t <sub>F</sub>	SDA Fall Time – READ			20		ns
t <sub>SU;DAT</sub>	Setup Time — READ	See Figure 9		560		ns
t <sub>HD;DAT</sub>	Holdup Time — READ	See Figure 9		615		ns
t <sub>SP</sub>	Input Filter			50		ns
C <sub>in</sub>	Input Capacitance	SDA or SCL		< 5		pF

- (1) The *Electrical Characteristics* tables list ensured specifications under the listed *Recommended Operating Conditions* except as otherwise modified or specified by the Electrical Characteristics Conditions and/or Notes. Typical specifications are estimations only and are not ensured.
- (2) Typical values represent most likely parametric norms at V<sub>DD</sub> = 3.3 V, T<sub>A</sub> = 25°C, and at the *Recommended Operating Conditions* at the time of product characterization and are not ensured.
- (3) Current into device pins is defined as positive. Current out of a device pin is defined as negative. Voltages are referenced to ground except VOD and ΔVOD, which are differential voltages.

## 7.8 Timing Requirements

		MIN	NOM	MAX	UNIT
t <sub>R</sub>	SDA RiseTime – READ		430		ns
t <sub>F</sub>	SDA Fall Time – READ		20		ns
t <sub>SU;DAT</sub>	Setup Time — READ		560		ns
t <sub>HD;DAT</sub>	Holdup Time — READ		615		ns
t <sub>SP</sub>	Input Filter		50		ns

## 7.9 Timing Requirements for the Serial Control Bus

Over 3.3-V supply and temperature ranges unless otherwise specified.

			MIN	NOM	MAX	UNIT
f <sub>SCL</sub>	SCL Clock Frequency	Standard Mode	0		100	kHz
		Fast Mode	0		400	kHz
t <sub>LOW</sub>	SCL Low Period	Standard Mode	4.7			μs
		Fast Mode	1.3			μs
t <sub>HIGH</sub>	SCL High Period	Standard Mode	4			μs
		Fast Mode	0.6			μs
t <sub>HD;STA</sub>	Hold time for a start or a repeated start condition (Figure 9)	Standard Mode	4			μs
		Fast Mode	0.6			μs
t <sub>SU;STA</sub>	Setup time for a start or a repeated start condition (Figure 9)	Standard Mode	4.7			μs
		Fast Mode	0.6			μs
t <sub>HD;DAT</sub>	Data Hold Time (Figure 9)	Standard Mode	0		3.45	μs
		Fast Mode	0		0.9	μs
t <sub>SU;DAT</sub>	Data Setup Time (Figure 9)	Standard Mode	250			ns
		Fast Mode	100			ns
t <sub>SU;STO</sub>	Setup Time for STOP Condition (Figure 9)	Standard Mode	4			μs
		Fast Mode	0.6			μs
t <sub>BUF</sub>	Bus Free Time between STOP and START (Figure 9)	Standard Mode	4.7			μs
		Fast Mode	1.3			μs
t <sub>r</sub>	SCL and SDA Rise Time (Figure 9)	Standard Mode			1000	ns
		Fast Mode			300	ns
t <sub>f</sub>	SCL and SDA Fall Time (Figure 9)	Standard Mode			300	ns
		Fast mode			300	ns

## 7.10 Switching Characteristics

over operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	PIN/FREQ.	MIN	TYP	MAX	UNIT
t <sub>RCP</sub>	PCLK Output Period	t <sub>RCP</sub> = t <sub>TCP</sub>	11.76	T	200	ns
t <sub>RDC</sub>	PCLK Output Duty Cycle		45%	50%	55%	
t <sub>CLH</sub>	LVCMOS Low-to-High Transition Time (Figure 3)	V <sub>DDIO</sub> = 1.71 to 1.89 V, C <sub>L</sub> = 12 pF		2	3	ns
		V <sub>DDIO</sub> = 3 to 3.6 V, C <sub>L</sub> = 12 pF		2	3	ns
t <sub>CHL</sub>	LVCMOS High-to-Low Transition Time (Figure 3)	V <sub>DDIO</sub> = 1.71 to 1.89 V, C <sub>L</sub> = 12 pF		2	3	ns
		V <sub>DDIO</sub> = 3 to 3.6 V, C <sub>L</sub> = 12 pF		2	3	ns
t <sub>ROS</sub>	Data Valid before PCLK – Setup Time SSCG = OFF (Figure 6)	V <sub>DDIO</sub> = 1.71 to 1.89 V, C <sub>L</sub> = 12 pF	2.2			ns
		V <sub>DDIO</sub> = 3 to 3.6 V, C <sub>L</sub> = 12 pF	2.2			ns
t <sub>ROH</sub>	Data Valid after PCLK – Hold Time SSCG = OFF (Figure 6)	V <sub>DDIO</sub> = 1.71 to 1.89 V, C <sub>L</sub> = 12 pF	3			ns
		V <sub>DDIO</sub> = 3 to 3.6 V, C <sub>L</sub> = 12 pF	3			ns

### Switching Characteristics (continued)

over operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	PIN/FREQ.	MIN	TYP	MAX	UNIT
t <sub>XZR</sub> Active to OFF Delay (Figure 5) <sup>(1) (2)</sup>	OEN = L, OSS_SEL = H	ROUT[23:0]		10		ns
		HS, VS, DE, PCLK, LOCK, PASS		15		ns
		MCLK, I2S_CLK, I2S_WC, I2S_DA, I2S_DB		60		ns
t <sub>DDL</sub> Lock Time (Figure 5) <sup>(1)(2)(3)</sup>	SSCG = OFF	f = 5 to 85MHz		5	40	ns
t <sub>DD</sub> Delay – Latency <sup>(1)(2)</sup>		f = 5 to 85MHz		147*T		ns
t <sub>DCCJ</sub> Cycle-to-Cycle Jitter <sup>(1)(2)</sup>	SSCG = OFF	f = 5 to <15 MHz		0.5		ns
		f = 15 to 85 MHz		0.2		ns
		I2S_CLK = 1 to 12.28MHz		±2		ns
t <sub>ONS</sub> Data Valid After OEN = H SetupTime (Figure 7) <sup>(1)(2)</sup>	VDDIO = 1.71 to 1.89 V, CL = 12 pF	ROUT[23:0], HS, VS, DE, PCLK, MCLK, I2S_CLK, I2S_WC, I2S_DA, I2S_DB		50		ns
	VDDIO = 3 to 3.6 V, CL = 12 pF			50		ns
t <sub>ONH</sub> Data Tri-State After OEN = L SetupTime (Figure 7) <sup>(1)(2)</sup>	VDDIO = 1.71 to 1.89 V, CL = 12 pF			50		ns
	VDDIO = 3 to 3.6 V, CL = 12 pF			50		ns
t <sub>SES</sub> Data Tri-State after OSS_SEL = H, Setup Time (Figure 7) <sup>(1)(2)</sup>	VDDIO = 1.71 to 1.89 V, CL = 12 pF			5		ns
	VDDIO = 3 to 3.6 V, CL = 12 pF			5		ns
t <sub>SEH</sub> Data to Low after OSS_SEL = L Setup Time (Figure 7) <sup>(1)(2)</sup>	VDDIO = 1.71 to 1.89 V, CL = 12 pF			5		ns
	VDDIO = 3 to 3.6 V, CL = 12 pF			5		ns

- (1) Specification is ensured by characterization and is not tested in production.
- (2) Specification is ensured by design and is not tested in production.
- (3) t<sub>DDL</sub> is the time required by the device to obtain lock when exiting power-down state with an active serial stream.

### 7.11 Timing Diagrams

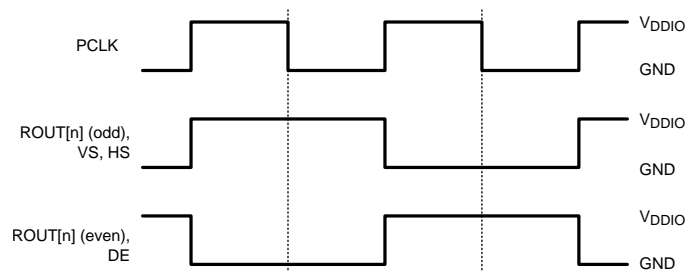


Figure 1. Checker Board Data Pattern

Timing Diagrams (continued)

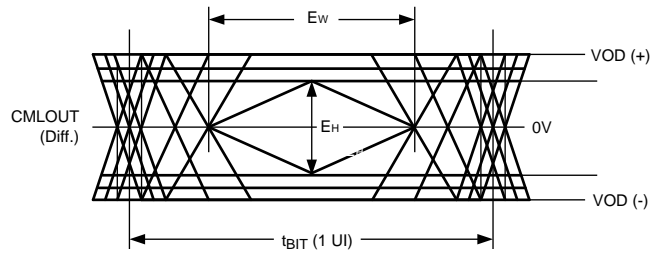


Figure 2. CML Output Driver

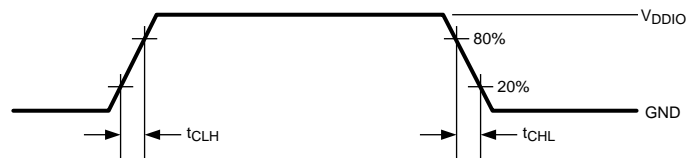


Figure 3. LVCMOS Transition Times

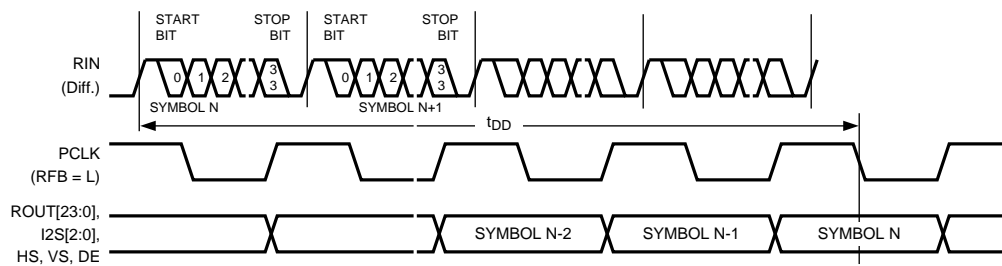


Figure 4. Delay - Latency

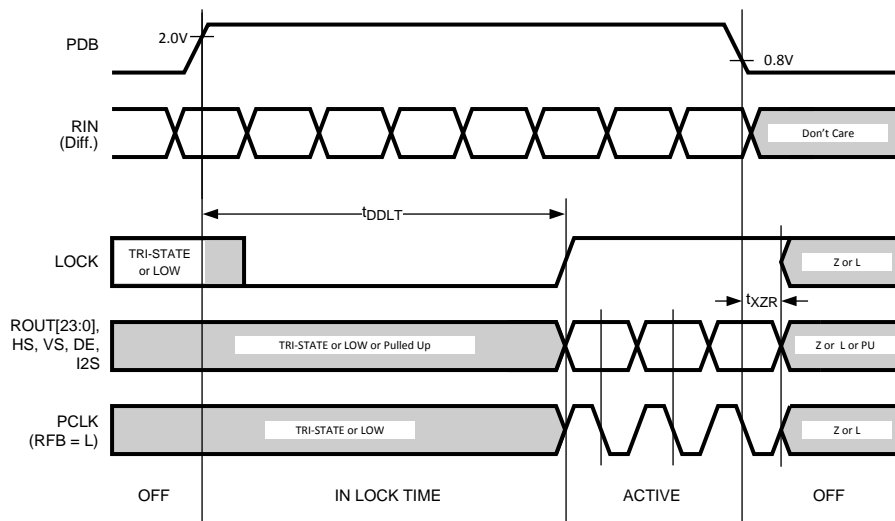


Figure 5. PLL Lock Times and PDB Tri-State Delay

Timing Diagrams (continued)

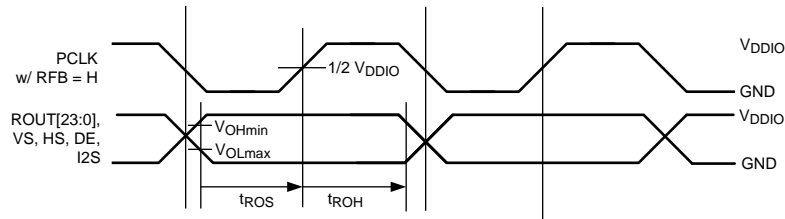


Figure 6. Output Data Valid (Setup and Hold) Times With SSCG = Off

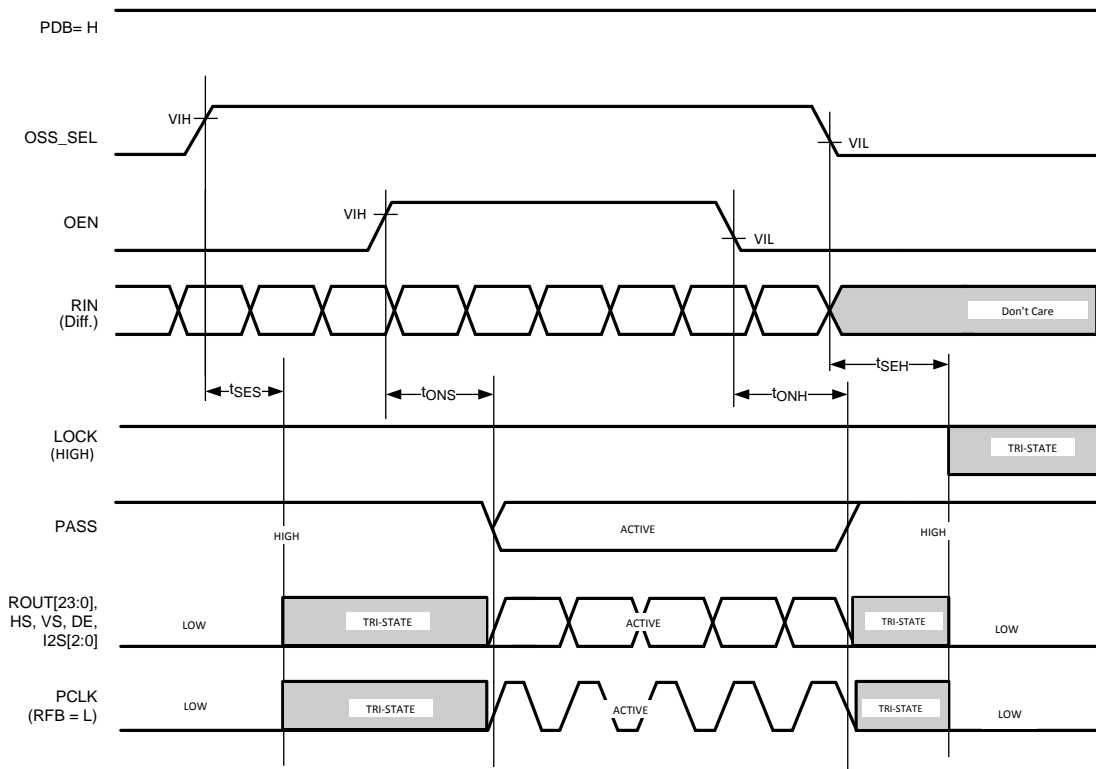


Figure 7. Output State (Setup and Hold) Times

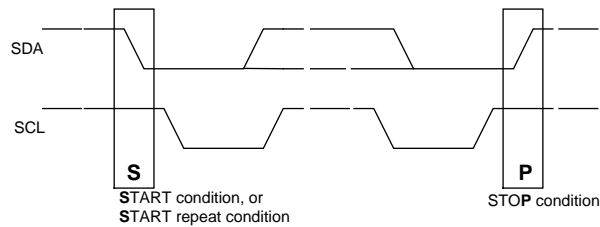


Figure 8. BIST PASS Waveform

Timing Diagrams (continued)

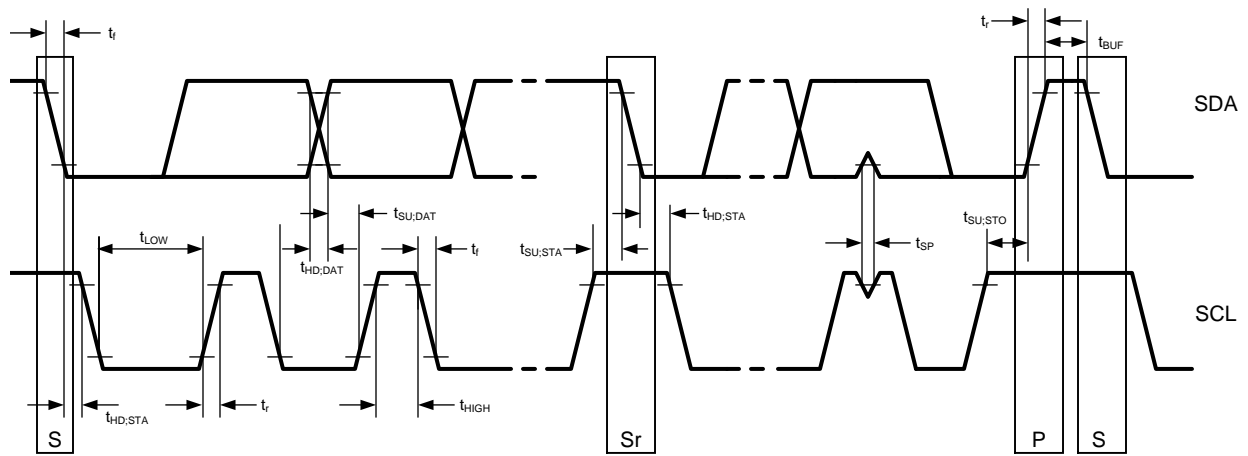
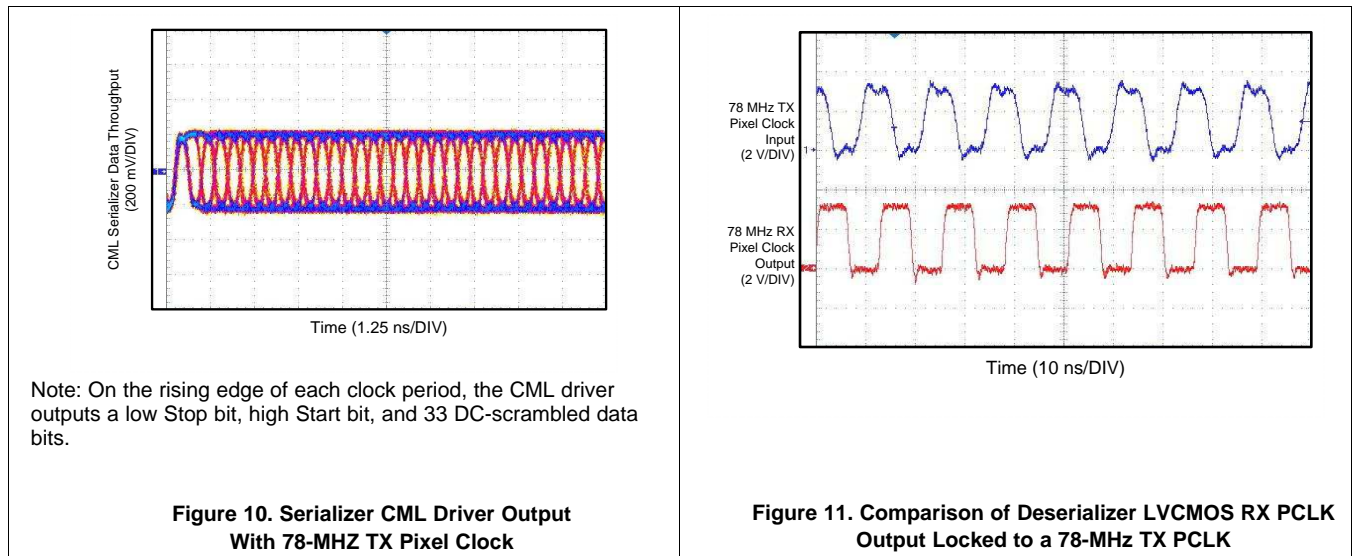


Figure 9. Serial Control Bus Timing Diagram

7.12 Typical Characteristics



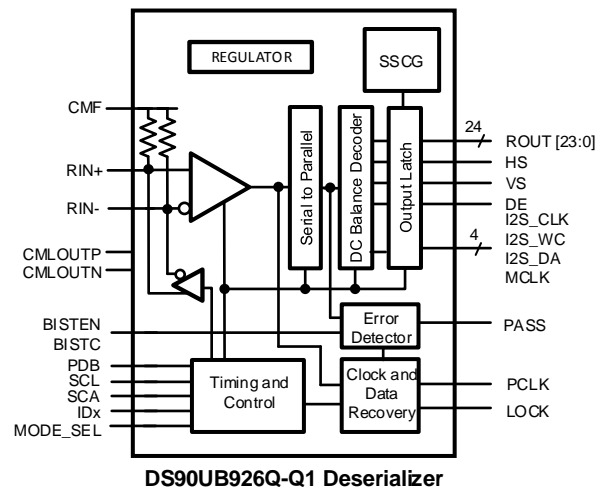
## 8 Detailed Description

### 8.1 Overview

The DS90UB926Q-Q1 deserializer receives 35 bits of data over a single serial FPD-Link III pair operating up to 2.975-Gbps application payload. The serial stream contains an embedded clock, video control signals, and the DC-balanced video data and audio data which enhance signal quality to support AC coupling.

The DS90UB926Q-Q1 deserializer attains lock to a data stream without the use of a separate reference clock source, which greatly simplifies system complexity and overall cost. The deserializer also synchronizes to the serializer regardless of the data pattern, delivering true automatic *plug and lock* performance. It can lock to the incoming serial stream without the need of special training patterns or sync characters. The deserializer recovers the clock and data by extracting the embedded clock information, validating then deserializing the incoming data stream. The recovered parallel LVCMOS video bus is then provided to the display. The deserializer is intended for use with the DS90UB925Q-Q1 serializer, but is also backward-compatible with DS90UR905Q or DS90UR907Q FPD-Link II serializer.

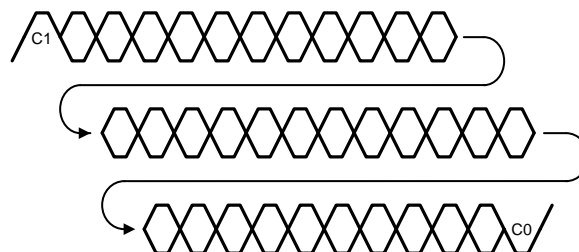
### 8.2 Functional Block Diagram



### 8.3 Feature Description

#### 8.3.1 High-Speed Forward Channel Data Transfer

The High-Speed Forward Channel (HS\_FC) is composed of 35 bits of data containing DIN[23:0] or RGB[7:0] or YUV data, sync signals, I2C, and I2S audio transmitted from Serializer to Deserializer. [Figure 12](#) shows the serial stream per PCLK cycle. This data payload is optimized for signal transmission over an AC-coupled link. Data is randomized, balanced, and scrambled.



**Figure 12. FPD-Link III Serial Stream**

## Feature Description (continued)

The device supports clocks in the range of 5 MHz to 85 MHz. The application payload rate is 2.975 Gbps maximum (175 Mbps minimum) with the actual line rate of 2.975 Gbps maximum and 525 Mbps minimum.

### 8.3.2 Low-Speed Back Channel Data Transfer

The low-speed backward channel (LS\_BC) of the DS90UB926Q-Q1 provides bidirectional communication between the display and host processor. The information is carried back from the Deserializer to the Serializer per serial symbol. The back channel control data is transferred over the single serial link along with the high-speed forward data, DC balance coding and embedded clock information. This architecture provides a backward path across the serial link together with a high-speed forward channel. The back channel contains the I2C, CRC, and 4 bits of standard GPIO information with 10-Mbps line rate.

### 8.3.3 Backward-Compatible Mode

The DS90UB926Q-Q1 is also backward-compatible to DS90UR905Q and DS90UR907Q FPD Link II serializers at 15- to 65-MHz pixel clock frequencies. It receives 28 bits of data over a single serial FPD-Link II pair operating at the line rate of 420 Mbps to 1.82 Gbps. This backward-compatible mode is provided through the MODE\_SEL pin ([Table 9](#)) or the configuration register ([Table 11](#)). In this mode, the minimum PCLK frequency is 15 MHz.

### 8.3.4 Input Equalization Gain

FPD-Link III input adaptive equalizer provides compensation for transmission medium losses and reduces the medium-induced deterministic jitter. It equalizes up to 10 meter STP cables with 3 connection breaks at maximum serialized stream payload rate of 2.975 Gbps.

### 8.3.5 Common-Mode Filter Pin (CMF)

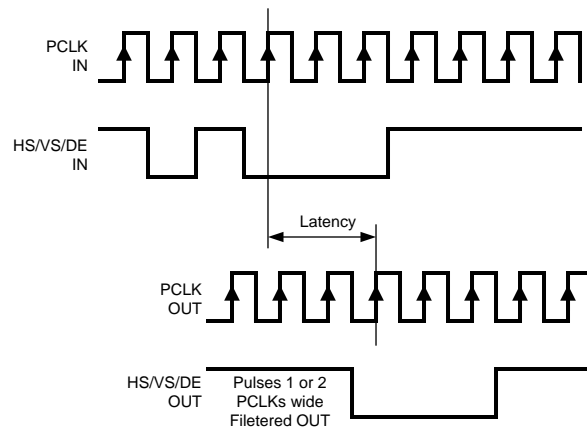
The deserializer provides access to the center tap of the internal termination. A capacitor must be placed on this pin for additional common-mode filtering of the differential pair. This can be useful in high noise environments for additional noise rejection capability. A 0.1- $\mu$ F capacitor has to be connected to this pin to Ground.

### 8.3.6 Video Control Signal Filter

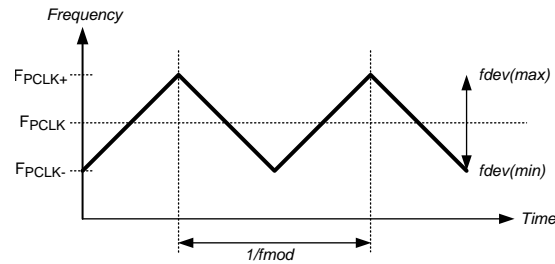
When operating the devices in Normal Mode, the Video Control Signals (DE, HS, VS) have the following restrictions:

- Normal Mode with Control Signal Filter Enabled: DE and HS — Only 2 transitions per 130 clock cycles are transmitted, the transition pulse must be 3 PCLK or longer.
- Normal Mode with Control Signal Filter Disabled: DE and HS — Only 2 transitions per 130 clock cycles are transmitted, no restriction on minimum transition pulse.
- VS — Only 1 transition per 130 clock cycles are transmitted, minimum pulse width is 130 clock cycles.

Video Control Signals are defined as low frequency signals with limited transitions. Glitches of a control signal can cause a visual display error. This feature allows for the chipset to validate and filter out any high-frequency noise on the control signals. See [Figure 13](#).

**Feature Description (continued)**

**Figure 13. Video Control Signal Filter Waveform**
**8.3.7 EMI Reduction Features**
**8.3.7.1 Spread Spectrum Clock Generation (SSCG)**

The DS90UB926Q-Q1 provides an internally generated spread-spectrum clock (SSCG) to modulate its outputs. Both clock and data outputs are modulated. This will aid to lower system EMI. Output SSCG deviations to  $\pm 2.5\%$  (5% total) at up to 100-kHz modulations are available. This feature may be controlled by register. See [Table 1](#), [Table 2](#), and [Table 11](#). Do not enable the SSCG feature if the source PCLK into the SER has a clock with spread spectrum already.


**Figure 14. SSCG Waveform**
**Table 1. SSCG Configuration  
LFMODE = L (15 to 85 MHz)**

SSCG CONFIGURATION (0x2C) LFMODE = L (15 to 85 MHz)			SPREAD SPECTRUM OUTPUT	
SSC[2]	SSC[1]	SSC[0]	Fdev (%)	Fmod (kHz)
L	L	L	$\pm 0.9$	PCLK / 2168
L	L	H	$\pm 1.2$	
L	H	L	$\pm 1.9$	
L	H	H	$\pm 2.5$	
H	L	L	$\pm 0.7$	PCLK / 1300
H	L	H	$\pm 1.3$	
H	H	L	$\pm 2$	
H	H	H	$\pm 2.5$	

**Table 2. SSCG Configuration  
LFMODE = H (5 to <15 MHz)**

SSCG CONFIGURATION (0x2C) LFMODE = H (5 to <15 MHz)			SPREAD SPECTRUM OUTPUT	
SSC[2]	SSC[1]	SSC[0]	Fdev (%)	Fmod (kHz)
L	L	L	±0.5	PCLK / 628
L	L	H	±1.3	
L	H	L	±1.8	
L	H	H	±2.5	
H	L	L	±0.7	PCLK / 388
H	L	H	±1.2	
H	H	L	±2	
H	H	H	±2.5	

### 8.3.8 Enhanced Progressive Turnon (EPTO)

The deserializer LVCMOS parallel outputs timing are delayed. Groups of 8-bit R, G and B outputs switch in a different time. This minimizes the number of outputs switching simultaneously and helps to reduce supply noise. In addition, it spreads the noise spectrum out reducing overall EMI.

### 8.3.9 LVCMOS VDDIO Option

The deserializer parallel bus can operate with 1.8-V or 3.3-V levels (VDDIO) for target (display) compatibility. The 1.8-V levels offers a lower noise (EMI) and also a system power savings.

### 8.3.10 Power Down (PDB)

The Serializer has a PDB input pin to ENABLE or POWER DOWN the device. This pin can be controlled by the host or through the V<sub>DDIO</sub>, where V<sub>DDIO</sub> = 3 V to 3.6 V or V<sub>DD33</sub>. To save power disable the link when the display is not needed (PDB = LOW). When the pin is driven by the host, make sure to release it after V<sub>DD33</sub> and V<sub>DDIO</sub> have reached final levels; no external components are required. In the case of driven by the V<sub>DDIO</sub> = 3 V to 3.6 V or V<sub>DD33</sub> directly, a 10-kΩ resistor to the V<sub>DDIO</sub> = 3 V to 3.6 V or V<sub>DD33</sub>, and a > 10-μF capacitor to the ground are required (see [Figure 24](#)).

### 8.3.11 Stop Stream Sleep

The deserializer enters a low power SLEEP state when the input serial stream is stopped. A STOP condition is detected when the embedded clock bits are not present. When the serial stream starts again, the deserializer then locks to the incoming signal and recover the data.

#### NOTE

In STOP STREAM SLEEP, the Serial Control Bus Registers values are retained.

### 8.3.12 Serial Link Fault Detect

The serial link fault detection is able to detect any of following 7 conditions

1. cable open
2. + to – short
3. + short to GND
4. - short to GND
5. + short to battery
6. - short to battery
7. cable is linked incorrectly

If any one of the fault conditions occurs, The Link Detect Status is 0 (cable is not detected) on the Serial Control Bus Register bit 0 of address 0x1C [Table 11](#). The link errors can be monitored though Link Error Count of the Serial Control Bus Register bit [4:0] of address 0x41 [Table 11](#).

### 8.3.13 Oscillator Output

The deserializer provides an optional PCLK output when the input clock (serial stream) has been lost. This is based on an internal oscillator. The frequency of the oscillator may be selected. This feature is controlled by register Address 0x02, bit 5 (OSC Clock Enable). See [Table 11](#).

### 8.3.14 Pixel Clock Edge Select (RFB)

The RFB determines the edge that the data is strobed on. If RFB is High (1), output data is strobed on the Rising edge of the PCLK. If RFB is Low ('0'), data is strobed on the Falling edge of the PCLK. This allows for interoperability with downstream devices. The deserializer output does not need to use the same edge as the Ser input. This feature may be controlled by register. See [Table 11](#).

### 8.3.15 Image Enhancement Features

Several image enhancement features are provided. White balance LUTs allow the user to define and target the color temperature of the display. Adaptive Hi-FRC dithering enables the presentation of “true-color” images on an 18-bit color display.

#### 8.3.15.1 White Balance

The white balance feature enables similar display appearance when using LCDs from different vendors. It compensates for native color temperature of the display, and adjusts relative intensities of R, G, and B to maintain specified color temperature. Programmable control registers are used to define the contents of three LUTs (8-bit color value for red, green and blue) for the white balance feature. The LUTs map input RGB values to new output RGB values. There are three LUTs, one LUT for each color. Each LUT contains 256 entries, 8 bits per entry with a total size of 6144 bits (3 x 256 x 8). All entries are readable and writable. Calibrated values are loaded into registers through the I2C interface (deserializer is a slave device). This feature may also be applied to lower color depth applications such as 18-bit (666) and 16-bit (565). White balance is enabled and configured through the serial control bus register.

##### 8.3.15.1.1 LUT Contents

The user must define and load the contents of the LUT for each color (R,G, and B). Regardless of the color depth being driven (888, 666, 656), the user must always provide contents for 3 complete LUTs - 256 colors x 8 bits x 3 tables. Unused bits - LSBs - shall be set to 0 by the user.

When 24-bit (888) input data is being driven to a 24-bit display, each LUT (R, G and B) must contain 256 unique 8-bit entries. The 8-bit white balanced data is then available at the output of the DS90UB926Q-Q1 deserializer, and driven to the display.

When 18-bit (666) input data is being driven to an 18-bit display, the white balance feature may be used in one of two ways. First, simply load each LUT with 256, 8-bit entries. Each 8-bit entry is a 6-bit value (6 MSBs) with the 2 LSBs set to 00. Thus as total of 64 unique 6-bit white balance output values are available for each color (R, G, and B). The 6-bit white balanced data is available at the output of the DS90UB926Q-Q1 deserializer, and driven directly to the display.

Alternatively, with 6-bit input data the user may choose to load complete 8-bit values into each LUT. This mode of operation provides the user with finer resolution at the LUT output to more closely achieve the desired white point of the calibrated display. Although 8-bit data is loaded, only 64 unique 8-bit white balance output values are available for each color (R, G, and B). The result is 8-bit white balanced data. Before driving to the output of the deserializer, the 8-bit data must be reduced to 6-bit with an FRC dithering function. To operate in this mode, the user must configure the DS90UB926Q-Q1 to enable the FRC2 function.

Examples of the three types of LUT configurations described are shown in [Figure 15](#)

**8.3.15.1.2 Enabling White Balance**

The user must load all 3 LUTs prior to enabling the white balance feature. The following sequence must be followed by the user.

To initialize white balance after power-on (Table 3):

1. Load contents of all 3 LUTs . This requires a sequential loading of LUTs - first RED, second GREEN, third BLUE. 256, 8-bit entries must be loaded to each LUT. Page registers must be set to select each LUT.
2. Enable white balance

By default, the LUT data may not be reloaded after initialization at power-on.

An option does exist to allow LUT reloading after power-on and initial LUT loading (as described above). This option may only be used after enabling the white balance reload feature through the associated serial control bus register. In this mode the LUTs may be reloaded by the master controller through the I2C. This provides the user with the flexibility to refresh LUTs periodically , or upon system requirements to change to a new set of LUT values. The host controller loads the updated LUT values through the serial bus interface. There is no need to disable the white balance feature while reloading the LUT data. Refreshing the white balance to the new set of LUT data will be seamless - no interruption of displayed data.

It is important to note that initial loading of LUT values requires that all 3 LUTs be loaded sequentially. When reloading, partial LUT updates may be made.

8-bit in / 8 bit out		6-bit in / 6 bit out		6-bit in / 8 bit out	
Gray level Entry	Data Out (8-bits)	Gray level Entry	Data Out (8-bits)	Gray level Entry	Data Out (8-bits)
0	0000000b	0	0000000b	0	0000001b
1	0000001b	1	N/A	1	N/A
2	0000011b	2	N/A	2	N/A
3	0000011b	3	N/A	3	N/A
4	00000110b	4	00000100b	4	00000110b
5	00000110b	5	N/A	5	N/A
6	00000111b	6	N/A	6	N/A
7	00000111b	7	N/A	7	N/A
8	00001000b	8	00001000b	8	00001011b
9	00001010b	9	N/A	9	N/A
10	00001001b	10	N/A	10	N/A
11	00001011b	11	N/A	11	N/A
⋮	⋮	⋮	⋮	⋮	⋮
248	11111010b	248	11111000b	248	11111010b
249	11111010b	249	N/A	249	N/A
250	11111011b	250	N/A	250	N/A
251	11111011b	251	N/A	251	N/A
252	11111110b	252	11111100b	252	11111111b
253	11111101b	253	N/A	253	N/A
254	11111101b	254	N/A	254	N/A
255	11111111b	255	N/A	255	N/A

**Figure 15. White Balance LUT Configurations**

**Table 3. White Balance Register Table**

PAGE	ADD (dec)	ADD (hex)	REGISTER NAME	BIT(s)	ACCESS	DEFAULT (hex)	FUNCTION	DESCRIPTION
0	42	0x2A	White Balance Control	7:6	RW	0x00	Page Setting	00: Configuration Registers 01: Red LUT 10: Green LUT 11: Blue LUT
				5	RW		White Balance Enable	0: White Balance Disable 1: White Balance Enable
				4	RW			0: Reload Disable 1: Reload Enable
				3:0				<b>Reserved</b>
1	0 – 255	00 – FF	White Balance Red LUT	FF:0	RW	N/A	Red LUT	256 8-bit entries to be applied to the Red subpixel data
2	0 – 255	00 – FF	White Balance Green LUT	FF:0	RW	N/A	Green LUT	256 8-bit entries to be applied to the Green subpixel data
3	0 – 255	00 – FF	White Balance Blue LUT	FF:0	RW	N/A	Blue LUT	256 8-bit entries to be applied to the Blue subpixel data

### 8.3.15.2 Adaptive HI-FRC Dithering

The adaptive FRC dithering feature delivers product-differentiating image quality. It reduces 24-bit RGB (8 bits per subpixel) to 18-bit RGB (6 bits per sub-pixel), smoothing color gradients, and allowing the flexibility to use lower cost 18-bit displays. Frame Rate Control (FRC) dithering is a method to emulate “missing” colors on a lower color depth LCD display by changing the pixel color slightly with every frame. FRC is achieved by controlling on and off pixels over multiple frames (Temporal). Static dithering regulates the number of on and off pixels in a small defined pixel group (Spatial). The FRC module includes both Temporal and Spatial methods and also Hi-FRC. Conventional FRC can display only 16,194,277 colors with 6-bit RGB source. “Hi-FRC” enables full (16,777,216) color on an 18-bit LCD panel. The “adaptive” FRC module also includes input pixel detection to apply specific Spatial dithering methods for smoother gray level transitions. When enabled, the lower LSBs of each RGB output are not active; only 18-bit data (6 bits per R,G and B) are driven to the display. This feature is enabled through the serial control bus register.

Two FRC functional blocks are available, and may be independently enabled. FRC1 precedes the white balance LUT, and is intended to be used when 24-bit data is being driven to an 18-bit display with a white balance LUT that is calibrated for an 18-bit data source. The second FRC block, FRC2, follows the white balance block and is intended to be used when fine adjustment of color temperature is required on an 18-bit color display, or when a 24-bit source drives an 18-bit display with a white balance LUT calibrated for 24-bit source data.

For proper operation of the FRC dithering feature, the user must provide a description of the display timing control signals. The timing mode, “sync mode” (HS, VS) or “DE only” must be specified, along with the active polarity of the timing control signals. All this information is entered to DS90UB926Q-Q1 control registers through the serial bus interface.

Adaptive Hi-FRC dithering consists of several components. Initially, the incoming 8-bit data is expanded to 9-bit data. This allows the effective dithered result to support a total of 16.7 million colors. The incoming 9-bit data is evaluated, and one of four possible algorithms is selected. The majority of incoming data sequences are supported by the default dithering algorithm. Certain incoming data patterns (black/white pixel, full on/off sub-pixel) require special algorithms designed to eliminate visual artifacts associated with these specific gray level transitions. Three algorithms are defined to support these critical transitions.

An example of the default dithering algorithm is illustrated in [Figure 16](#). The 1 or 0 value shown in the table describes whether the 6-bit value is increased by 1 (1) or left unchanged (0). In this case, the 3 truncated LSBs are 001.

<b>F0L0</b>	Frame = 0, Line = 0							
<b>PD1</b>	Pixel Data one							
<b>Cell Value 010</b>	R[7:2]+0, G[7:2]+1, B[7:2]+0							
<b>LSB=001</b>	three lsb of 9 bit data (8 to 9 for Hi-Frc)							

Pixel Index	PD1	PD2	PD3	PD4	PD5	PD6	PD7	PD8	
<b>LSB = 001</b>									
F0L0	010	000	000	000	000	000	010	000	R = 4/32 G = 4/32 B = 4/32
F0L1	101	000	000	000	101	000	000	000	
F0L2	000	000	010	000	010	000	000	000	
F0L3	000	000	101	000	000	000	101	000	
F1L0	000	000	000	000	000	000	000	000	R = 4/32 G = 4/32 B = 4/32
F1L1	000	111	000	000	000	111	000	000	
F1L2	000	000	000	000	000	000	000	000	
F1L3	000	000	000	111	000	000	000	111	
F2L0	000	000	010	000	010	000	000	000	R = 4/32 G = 4/32 B = 4/32
F2L1	000	000	101	000	000	000	101	000	
F2L2	010	000	000	000	000	000	010	000	
F2L3	101	000	000	000	101	000	000	000	
F3L0	000	000	000	000	000	000	000	000	R = 4/32 G = 4/32 B = 4/32
F3L1	000	000	000	111	000	000	000	111	
F3L2	000	000	000	000	000	000	000	000	
F3L3	000	111	000	000	000	111	000	000	

Figure 16. Default FRC Algorithm

See Table 4 for recommended FRC settings dependant on 18/24-bit source, 18/24-bit white balance LUT, and 18/24-bit display.

Table 4. Recommended FRC settings

SOURCE	WHITE BALANCE LUT	DISPLAY	FRC1	FRC2
24-bit	24-bit	24-bit	Disabled	Disabled
24-bit	24-bit	18-bit	Disabled	Enabled
24-bit	18-bit	18-bit	Enabled	Disabled
18-bit	24-bit	24-bit	Disabled	Disabled
18-bit	24-bit	18-bit	Disabled	Enabled
18-bit	18-bit	18-bit	Disabled	Disabled

### 8.3.16 Internal Pattern Generation

The DS90UB926Q-Q1 serializer supports the internal pattern generation feature. It allows basic testing and debugging of an integrated panel. The test patterns are simple and repetitive and allow for a quick visual verification of panel operation. As long as the device is not in power-down mode, the test pattern will be displayed even if no parallel input is applied. If no PCLK is received, the test pattern can be configured to use a programmed oscillator frequency. For detailed information, refer to [AN-2198 Exploring the Internal Test Pattern Generation Feature of 720p FPD-Link III Devices](#) (SNLA132).

### 8.3.17 Built-In Self Test (BIST)

An optional at-speed built-in self test (BIST) feature supports the testing of the high speed serial link and the low-speed back channel. This is useful in the prototype stage, equipment production, in-system test, and also for system diagnostics.

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#### NOTE

BIST is not available in backward-compatible mode.

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#### 8.3.17.1 BIST Configuration and Status

The BIST mode is enabled at the deserializer by the pin select (Pin 44 BISTEN and Pin 16 BISTC) or configuration register (Table 11) through the deserializer. When LFMODE = 0, the pin-based configuration defaults to external PCLK or 33-MHz internal oscillator clock (OSC) frequency. In the absence of PCLK, the user can select the desired OSC frequency (default 33 MHz or 25 MHz) through the register bit. When LFMODE = 1, the pin based configuration defaults to external PCLK or 12.5MHz internal oscillator clock (OSC) frequency.

When BISTEN of the deserializer is high, the BIST mode enable information is sent to the serializer through the Back Channel. The serializer outputs a test pattern and drives the link at speed. The deserializer detects the test pattern and monitors it for errors. The PASS output pin toggles to flag any payloads that are received with 1 to 35 bit errors.

The BIST status is monitored real time on PASS pin. The result of the test is held on the PASS output until reset (new BIST test or Power Down). A high on PASS indicates NO ERRORS were detected. A Low on PASS indicates one or more errors were detected. The duration of the test is controlled by the pulse width applied to the deserializer BISTEN pin. This BIST feature also contains a Link Error Count and a Lock Status. If the connection of the serial link is broken, then the link error count is shown in the register. When the PLL of the deserializer is locked or unlocked, the lock status can be read in the register. See Table 11.

##### 8.3.17.1.1 Sample BIST Sequence

See Figure 17 for the BIST mode flow diagram.

1. For the DS90UB925Q-Q1 and DS90UB926Q-Q1 FPD-Link III chipset, BIST Mode is enabled through the BISTEN pin of DS90UB926Q-Q1 FPD-Link III deserializer. The desired clock source is selected through BISTC pin.
2. The DS90UB925Q-Q1 serializer is woken up through the back channel if it is not already on. The all zero pattern on the data pins is sent through the FPD-Link III to the deserializer. Once the serializer and the deserializer are in BIST mode and the deserializer acquires Lock, the PASS pin of the deserializer goes high and BIST starts checking the data stream. If an error in the payload (1 to 35) is detected, the PASS pin will switch low for one half of the clock period. During the BIST test, the PASS output can be monitored and counted to determine the payload error rate.
3. To Stop the BIST mode, the deserializer BISTEN pin is set Low. The deserializer stops checking the data. The final test result is held on the PASS pin. If the test ran error free, the PASS output will be High. If there was one or more errors detected, the PASS output will be Low. The PASS output state is held until a new BIST is run, the device is RESET, or Powered Down. The BIST duration is user controlled by the duration of the BISTEN signal.
4. The Link returns to normal operation after the deserializer BISTEN pin is low. Figure 18 shows the waveform diagram of a typical BIST test for two cases. Case 1 is error free, and Case 2 shows one with multiple errors. In most cases it is difficult to generate errors due to the robustness of the link (differential data transmission etc.), thus they may be introduced by greatly extending the cable length, faulting the interconnect, reducing signal condition enhancements ( Rx Equalization).

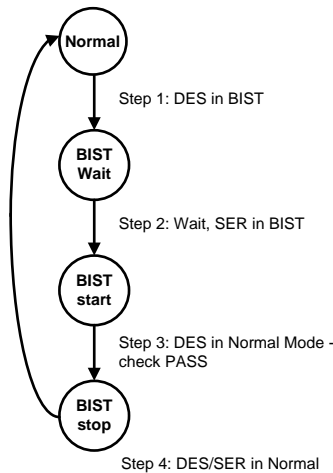


Figure 17. BIST Mode Flow Diagram

8.3.17.2 Forward Channel And Back Channel Error Checking

While in BIST mode, the serializer stops sampling RGB input pins and switches over to an internal all-zero pattern. The internal all-zeroes pattern goes through scrambler, DC-balancing, and so forth, and goes over the serial link to the deserializer. The deserializer on locking to the serial stream compares the recovered serial stream with all-zeroes and records any errors in status registers and dynamically indicates the status on PASS pin. The deserializer then outputs a SSO pattern on the RGB output pins.

The back-channel data is checked for CRC errors once the serializer locks onto back-channel serial stream as indicated by link detect status (register bit 0x0C[0]). The CRC errors are recorded in an 8-bit register. The register is cleared when the serializer enters the BIST mode. As soon as the serializer exits BIST mode, the functional mode CRC register starts recording the CRC errors. The BIST mode CRC error register is active in BIST mode only and keeps the record of last BIST run until cleared or enters BIST mode again.

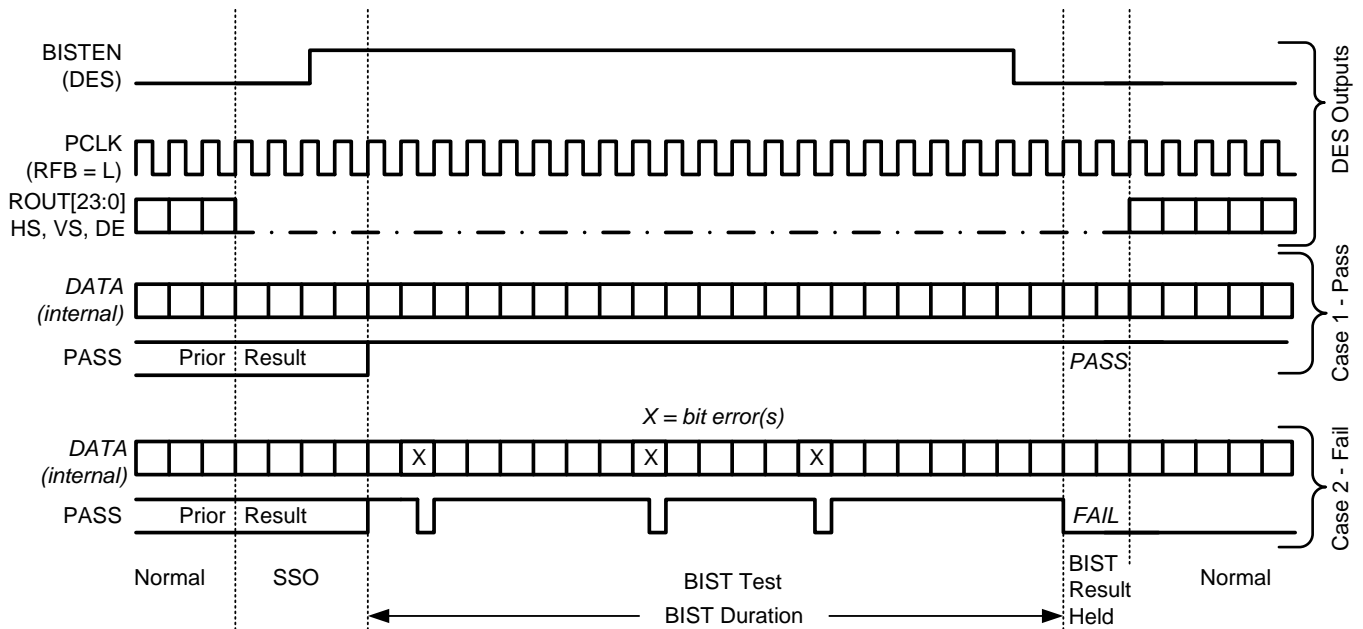


Figure 18. Bist Waveforms

### 8.3.18 I2S Receiving

In normal 24-bit RGB operation mode, the DS90UB926Q-Q1 provides up to 3-bit of I2S. They are I2S\_CLK, I2S\_WC and I2S\_DA, as well as the Master I2S Clock (MCLK). The audio is received through the forward video frame, or can be configured to receive during video blanking periods. A jitter cleaning feature reduces I2S\_CLK output jitter to +/- 2ns.

#### 8.3.18.1 I2S Jitter Cleaning

The DS90UB926Q-Q1 features a standalone PLL to clean the I2S data jitter supporting high end car audio systems. If I2S CLK frequency is less than 1MHz, this feature has to be disabled through the register bit I2S Control (0x2B) in [Table 10](#)

#### 8.3.18.2 Secondary I2S Channel

In 18-bit RGB operation mode, the secondary I2S data (I2S\_DB) can be used as the additional I2S audio channel in addition to the 3-bit of I2S. The I2S\_DB is synchronized to the I2S\_CLK. To enable this synchronization feature on this bit, set the MODE\_SEL ([Table 9](#)) or program through the register bit ([Table 11](#)).

##### 8.3.18.2.1 MCLK

The deserializer has an I2S Master Clock Output. It supports x1, x2, or x4 of I2S CLK Frequency. When the I2S PLL is disabled, the MCLK output is off. [Table 5](#) below covers the range of I2S sample rates and MCLK frequencies. By default, all the MCLK output frequencies are x2 of the I2S CLK frequencies. The MCLK frequencies can also be enabled through the register bit [7:4] (I2S MCLK Output) of 0x3A shown in [Table 11](#). To select desired MCLK frequency, write bit 7 (0x3A) = 1, then write to bit [6:4] accordingly.

**Table 5. Audio Interface Frequencies**

SAMPLE RATE (kHz)	I2S DATA WORD SIZE (BITS)	I2S CLK (MHz)	MCLK OUTPUT (MHz)	REGISTER 0x3A[6:4]b
32	16	1.024	I2S_CLK x1	000
			I2S_CLK x2	001
			I2S_CLK x4	010
44.1		1.4112	I2S_CLK x1	000
			I2S_CLK x2	001
			I2S_CLK x4	010
48		1.536	I2S_CLK x1	000
			I2S_CLK x2	001
			I2S_CLK x4	010
96		3.072	I2S_CLK x1	001
			I2S_CLK x2	010
			I2S_CLK x4	011
192	6.144	I2S_CLK x1	010	
		I2S_CLK x2	011	
		I2S_CLK x4	100	

**Table 5. Audio Interface Frequencies (continued)**

SAMPLE RATE (kHz)	I2S DATA WORD SIZE (BITS)	I2S CLK (MHz)	MCLK OUTPUT (MHz)	REGISTER 0x3A[6:4]’b
32	24	1.536	I2S_CLK x1	000
			I2S_CLK x2	001
			I2S_CLK x4	010
44.1		2.117	I2S_CLK x1	001
			I2S_CLK x2	010
			I2S_CLK x4	011
48		2.304	I2S_CLK x1	001
			I2S_CLK x2	010
			I2S_CLK x4	011
96		4.608	I2S_CLK x1	010
			I2S_CLK x2	011
			I2S_CLK x4	100
192	9.216	I2S_CLK x1	011	
		I2S_CLK x2	100	
		I2S_CLK x4	101	
32	32	2.048	I2S_CLK x1	001
			I2S_CLK x2	010
			I2S_CLK x4	011
44.1		2.8224	I2S_CLK x1	001
			I2S_CLK x2	010
			I2S_CLK x4	011
48		3.072	I2S_CLK x1	001
			I2S_CLK x2	010
			I2S_CLK x4	011
96		6.144	I2S_CLK x1	010
			I2S_CLK x2	011
			I2S_CLK x4	100
192	12.288	I2S_CLK x1	011	
		I2S_CLK x2	100	
		I2S_CLK x4	110	

### 8.3.19 Interrupt Pin — Functional Description and Usage (INTB)

1. On DS90UB925Q-Q1, set register 0xC6[5] = 1 and 0xC6[0] = 1
2. DS90UB926Q-Q1 deserializer INTB\_IN (pin 16) is set LOW by some downstream device.
3. DS90UB925Q-Q1 serializer pulls INTB (pin 31) LOW. The signal is active low, so a LOW indicates an interrupt condition.
4. External controller detects INTB = LOW; to determine interrupt source, read ISR register .
5. A read to ISR will clear the interrupt at the DS90UB925Q-Q1, releasing INTB.
6. The external controller typically must then access the remote device to determine downstream interrupt source and clear the interrupt driving INTB\_IN. This would be when the downstream device releases the INTB\_IN (pin 16) on the DS90UB926Q-Q1. The system is now ready to return to step (1) at next falling edge of INTB\_IN.

### 8.3.20 GPIO[3:0] and GPO\_REG[8:4]

In 18-bit RGB operation mode, the optional R[1:0] and G[1:0] of the DS90UB926Q-Q1 can be used as the general purpose IOs GPIO[3:0] in either forward channel (Outputs) or back channel (Inputs) application.

#### GPIO[3:0] Enable Sequence

See [Table 6](#) for the GPIO enable sequencing.

1. Enable the 18-bit mode either through the configuration register bit [Table 11](#) on DS90UB925Q-Q1 only. DS90UB926Q-Q1 is automatically configured as in the 18-bit mode.
2. To enable GPIO3 forward channel, write 0x03 to address 0x0F on DS90UB925Q-Q1, then write 0x05 to address 0x1F on DS90UB926Q-Q1.

**Table 6. GPIO Enable Sequencing Table**

NO.	DESCRIPTION	DEVICE	FORWARD CHANNEL	BACK CHANNEL
1	Enable 18-bit mode	DS90UB925Q-Q1	0x12 = 0x04	0x12 = 0x04
		DS90UB926Q-Q1	Auto Load from DS90UB925Q-Q1	Auto Load from DS90UB925Q-Q1
2	GPIO3	DS90UB925Q-Q1	0x0F = 0x03	0x0F = 0x05
		DS90UB926Q-Q1	0x1F = 0x05	0x1F = 0x03
3	GPIO2	DS90UB925Q-Q1	0x0E = 0x30	0x0E = 0x50
		DS90UB926Q-Q1	0x1E = 0x50	0x1E = 0x30
4	GPIO1	DS90UB925Q-Q1	0x0E = 0x03	0x0E = 0x05
		DS90UB926Q-Q1	0x1E = 0x05	0x0E = 0x05
5	GPIO0	DS90UB925Q-Q1	0x0D = 0x93	0x0D = 0x95
		DS90UB926Q-Q1	0x1D = 0x95	0x1D = 0x93

### 8.3.20.1 GPO\_REG[8:4] Enable Sequence

GPO\_REG[8:4] are the outputs only pins. They must be programmed through the local register bits. See [Table 7](#) for the GPO\_REG enable sequencing.

1. Enable the 18-bit mode either through the configuration register bit [Table 11](#) on DS90UB925Q-Q1 only. DS90UB926Q-Q1 is automatically configured as in the 18-bit mode.
2. To enable GPO\_REG8 outputs a 1, write 0x90 to address 0x21 on DS90UB926Q-Q1.

**Table 7. GPO\_REG Enable Sequencing Table**

NO.	DESCRIPTION	DEVICE	LOCAL ACCESS	LOCAL OUTPUT VALUE
1	Enable 18-bit mode	DS90UB926Q-Q1	0x12 = 0x04 (on DS90UB925Q-Q1)	
2	GPO_REG8	DS90UB926Q-Q1	0x21 = 0x90	1
			0x21 = 0x10	0
3	GPO_REG7	DS90UB926Q-Q1	0x21 = 0x09	1
			0x21 = 0x01	1
4	GPO_REG6	DS90UB926Q-Q1	0x20 = 0x90	0
			0x20 = 0x10	1
5	GPO_REG5	DS90UB926Q-Q1	0x20 = 0x09	1
			0x20 = 0x01	0
6	GPO_REG4	DS90UB926Q-Q1	0x1F = 0x90	1
			0x1F = 0x10	0

## 8.4 Device Functional Modes

### 8.4.1 Clock-Data Recovery Status Flag (LOCK), Output Enable (OEN) and Output State Select (OSS\_SEL)

When PDB is driven HIGH, the CDR PLL begins locking to the serial input and LOCK is TRI-STATE or LOW (depending on the value of the OEN setting). After the DS90UB926Q-Q1 completes its lock sequence to the input serial data, the LOCK output is driven HIGH, indicating valid data and clock recovered from the serial input is available on the parallel bus and PCLK outputs. The State of the outputs are based on the OEN and OSS\_SEL setting (Table 8) or register bit (Table 11). See Figure 7.

Table 8. Output States

INPUTS				OUTPUTS			
SERIAL INPUT	PDB	OEN	OSS_SEL	LOCK	PASS	DATA, GPIO, I2S	CLK
X	0	X	X	Z	Z	Z	Z
X	1	0	0	L or H	L	L	L
X	1	0	1	L or H	Z	Z	Z
Static	1	1	0	L	L	L	L/OSC (Register bit enable)
Static	1	1	1	L	Previous Status	L	L
Active	1	1	0	H	L	L	L
Active	1	1	1	H	Valid	Valid	Valid

### 8.4.2 Low Frequency Optimization (LFMODE)

The LFMODE is set through the register (Table 11) or MODE\_SEL Pin 24 (Table 9). It controls the operating frequency of the deserializer. If LFMODE is Low (default), the PCLK frequency is between 15 MHz and 85 MHz. If LFMODE is High, the PCLK frequency is between 5 MHz and <15 MHz. Please note when the device LFMODE is changed, a PDB reset is required.

### 8.4.3 Configuration Select (MODE\_SEL)

Configuration of the device may be done through the MODE\_SEL input pin, or through the configuration register bit. A pullup resistor and a pulldown resistor of suggested values may be used to set the voltage ratio of the MODE\_SEL input ( $V_{R4}$ ) and  $V_{DD33}$  to select one of the other 10 possible selected modes. See Figure 19 and Table 9.

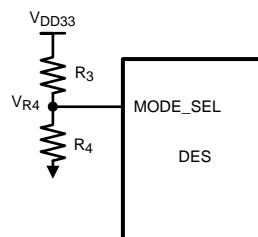


Figure 19. MODE\_SEL Connection Diagram

**Table 9. Configuration Select (MODE\_SEL)**

NO.	IDEAL RATIO $V_{R4}/V_{DD33}$	IDEAL $V_{R4}$ (V)	SUGGESTED RESISTOR R3 k $\Omega$ (1% tolerance)	SUGGESTED RESISTOR R4 k $\Omega$ (1% tolerance)	LFMODE <sup>(1)</sup>	Repeater <sup>(2)</sup>	BACKWARD COMPATIBLE <sup>(3)</sup>	I2S CHANNEL B (18-bit Mode) <sup>(4)</sup>
1	0	0	Open	40.2	L	L	L	L
2	0.123	0.407	115	16.2	L	L	L	H
3	0.167	0.552	121	24.3	L	H	L	L
4	0.227	0.748	162	47.5	L	H	L	H
5	0.291	0.960	137	56.2	H	L	L	L
6	0.366	1.209	107	61.9	H	L	L	H
7	0.458	1.510	113	95.3	H	H	L	L
8	0.542	1.790	95.3	113	H	H	L	H
9	0.611	2.016	73.2	115	L	L	H	L

(1) LFMODE: L = 15 to 85 MHz (Default); H = 5 to <15 MHz

(2) Repeater: L = Repeater Off (Default); H = Repeater On

(3) Backward Compatible: L = Backward Compatible Off (Default); H = Backward Compatible On to 905/907 (15 to 65 MHz)

(4) I2S Channel B: L = I2S Channel B Off, Normal 24-bit RGB Mode (Default); H = I2S Channel B On, 18-bit RGB Mode with I2S\_DB Enabled.

#### 8.4.4 Repeater Application

The DS90UB925Q-Q1 and DS90UB926Q-Q1 can be configured to extend data transmission over multiple links to multiple display devices. Setting the devices into repeater mode provides a mechanism for transmitting to all receivers in the system.

In a repeater application, in this document, the DS90UB925Q-Q1 is referred to as the Transmitter or transmit port (TX), and the DS90UB926Q-Q1 is referred to as the Receiver (RX). [Figure 20](#) shows the maximum configuration supported for Repeater implementations using the DS90UB925Q-Q1 (TX) and DS90UB926Q-Q1 (RX). Two levels of Repeaters are supported with a maximum of three Transmitters per Receiver.

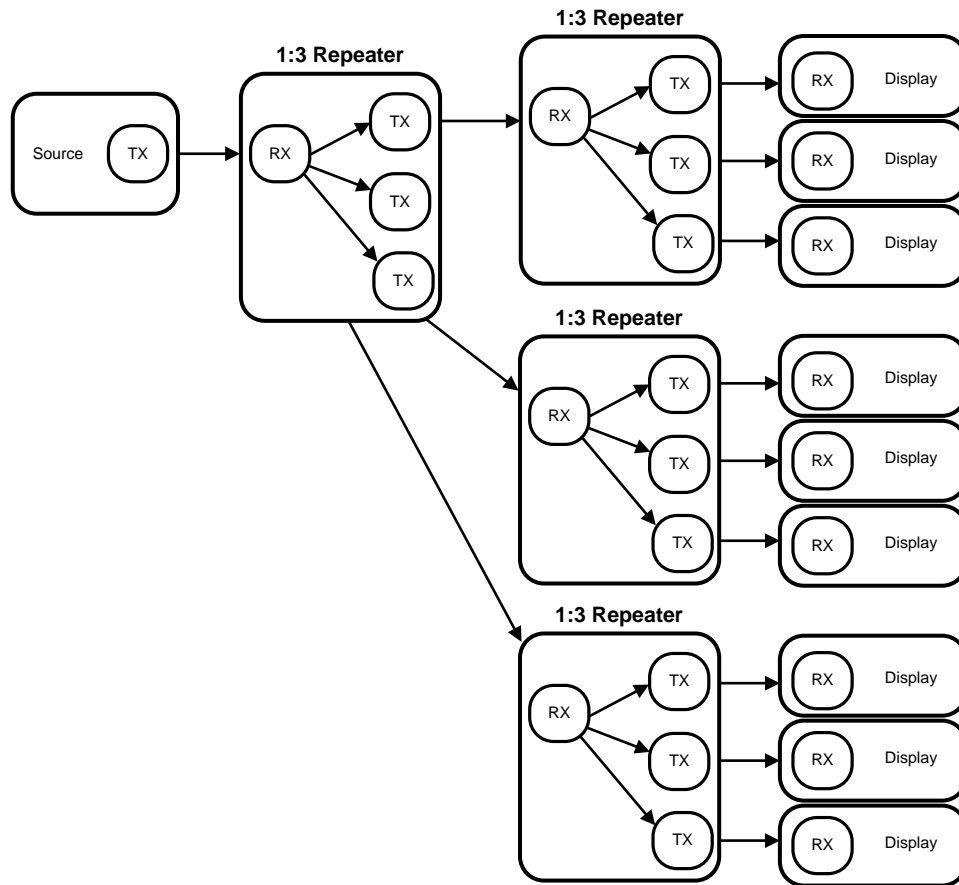


Figure 20. Maximum Repeater Application

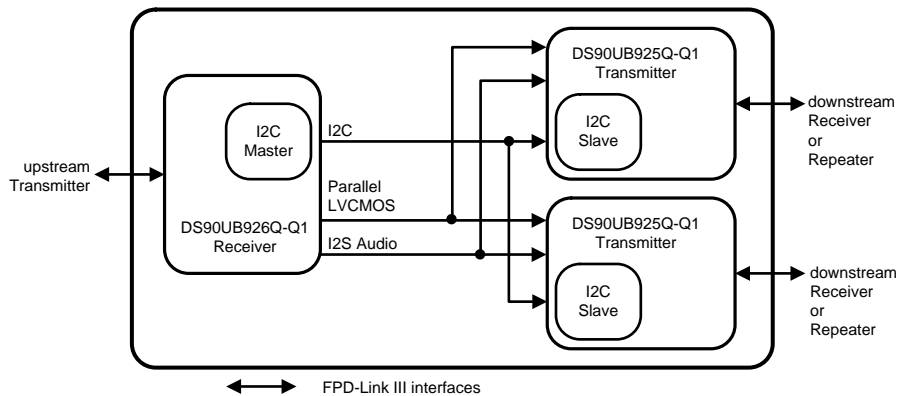


Figure 21. 1:2 Repeater Configuration

In a repeater application, the I2C interface at each TX and RX may be configured to transparently pass I2C communications upstream or downstream to any I2C device within the system. This includes a mechanism for assigning alternate IDs (Slave Aliases) to downstream devices in the case of duplicate addresses.

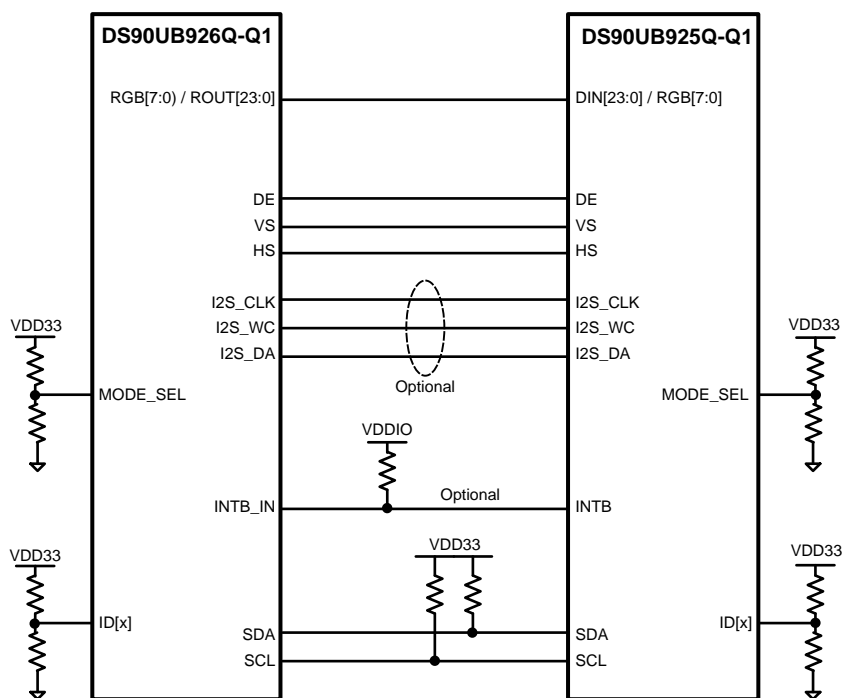
At each repeater node, the parallel LVCMOS interface fans out to up to three serializer devices, providing parallel RGB video data, HS/VS/DE control signals and, optionally, packetized audio data (transported during video blanking intervals). Alternatively, the I2S audio interface may be used to transport digital audio data between receiver and transmitters in place of packetized audio. All audio and video data is transmitted at the output of the Receiver and is received by the Transmitter..

Figure 21 provides more detailed block diagram of a 1:2 repeater configuration.

#### 8.4.4.1 Repeater Connections

The Repeater requires the following connections between the Receiver and each Transmitter for Figure 22:

1. Video Data – Connect PCLK, RGB and control signals (DE, VS, HS).
2. I2C – Connect SCL and SDA signals. Both signals should be pulled up to  $V_{DD33}$  with 4.7-k $\Omega$  resistors.
3. Audio – Connect I2S\_CLK, I2S\_WC, and I2S\_DA signals.
4. IDx pin – Each Transmitter and Receiver must have a unique I2C address.
5. MODE\_SEL pin – All Transmitter and Receiver must be set into the Repeater Mode.
6. Interrupt pin– Connect DS90UB926Q-Q1 INTB\_IN pin to DS90UB925Q-Q1 INTB pin. The signal must be pulled up to  $V_{DDIO}$ .



**Figure 22. Repeater Connection Diagram**

## 8.5 Programming

### 8.5.1 Serial Control Bus

The DS90UB926Q-Q1 is configured by the use of a serial control bus that is I2C protocol compatible. Multiple deserializer devices may share the serial control bus since 16 device addresses are supported. Device address is set through the  $R_1$  and  $R_2$  values on IDx pin. See Figure 23.

The serial control bus consists of two signals and a configuration pin. The SCL is a Serial Bus Clock Input / Output. The SDA is the Serial Bus Data Input / Output signal. Both SCL and SDA signals require an external pullup resistor to  $V_{DD33}$ . For most applications a 4.7-k $\Omega$  pullup resistor to  $V_{DD33}$  may be used. The resistor value may be adjusted for capacitive loading and data rate requirements. The signals are either pulled High, or driven Low.

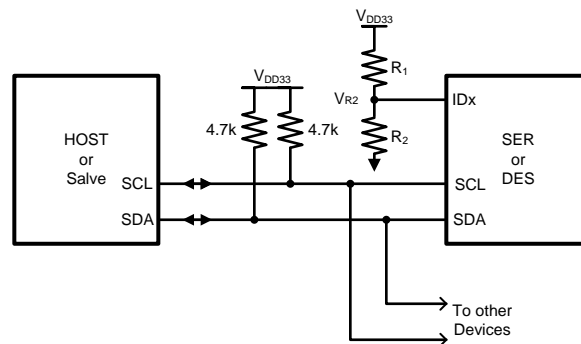


Figure 23. Serial Control Bus Connection

The configuration pin is the IDx pin. This pin sets one of 16 possible device addresses. A pullup resistor and a pull-down resistor of suggested values may be used to set the voltage ratio of the IDx input ( $V_{R2}$ ) and  $V_{DD33}$  to select one of the other 16 possible addresses. See Table 10.

Table 10. Serial Control Bus Addresses for IDx

NO.	IDEAL RATIO $V_{R2} / V_{DD33}$	IDEAL $V_{R2}$ (V)	SUGGESTED RESISTOR R1 k $\Omega$ (1% tol)	SUGGESTED RESISTOR R2 k $\Omega$ (1% tol)	ADDRESS 7'b	ADDRESS 8'b APPENDED
1	0	0	Open	40.2	0x2C	0x58
2	0.123	0.406	124	17.4	0x2D	0x5A
3	0.151	0.500	107	19.1	0x2E	0x5C
4	0.181	0.597	133	29.4	0x2F	0x5E
5	0.210	0.694	113	30.1	0x30	0x60
6	0.240	0.791	137	43.2	0x31	0x62
7	0.268	0.885	102	37.4	0x32	0x64
8	0.303	0.999	115	49.9	0x33	0x66
9	0.344	1.137	102	53.6	0x34	0x68
10	0.389	1.284	115	73.2	0x35	0x6A
11	0.430	1.418	115	86.6	0x36	0x6C
12	0.476	1.572	56.2	51.1	0x37	0x6E
13	0.523	1.725	93.1	102	0x38	0x70
14	0.565	1.863	82.5	107	0x39	0x72
15	0.611	2.016	73.2	115	0x3A	0x74
16	0.677	2.236	57.6	121	0x3B	0x76

## 8.6 Register Maps

**Table 11. Serial Control Bus Registers**

ADD (dec)	ADD (hex)	Register Name	Bit(s)	Register Type	Default (hex)	Function	Descriptions
0	0x00	I2C Device ID	7:1	RW		Device ID	7-bit address of Deserializer See <a href="#">Table 9</a>
			0	RW		ID Setting	I2C ID Setting 1: Register I2C Device ID (Overrides IDx pin) 0: Device ID is from IDx pin
1	0x01	Reset	7	RW	0x04	Remote Auto Power Down	Remote Auto Power Down 1: Power down when no forward channel link is detected 0: Do not power down when no forward channel link is detected
			6:3				<b>Reserved</b>
			2	RW		BC Enable	Back channel enable 1: Enable 0: Disable
			1	RW		Digital RESET1	Reset the entire digital block including registers This bit is self-clearing. 1: Reset 0: Normal operation
			0	RW		Digital RESET0	Reset the entire digital block except registers This bit is self-clearing 1: Reset 0: Normal operation
2	0x02	Configuration [0]	7	RW	0x00	Output Enable	LVCMOS Output Enable. 1: Enable 0: Disable. Tri-state Outputs
			6	RW		OEN and OSS_SEL Override	Overrides Output Enable Pin and Output State pin 1: Enable override 0: Disable - no override
			5	RW		OSC Clock Enable	OSC Clock Output Enable If loss of lock OSC clock is output onto PCLK 0: Disable 1: Enable
			4	RW		Output Sleep State Select (OSS_SEL)	OSS Select to Control Output State during Lock Low Period 1: Enable 0: Disable
			3	RW		Backward Compatible Mode Override	Mode_Sel Backward compatible Mode Override Enable. 1: Use register bit "reg_02[2]" to set BC Mode 0: Use MODE_SEL option.
			2	RW		Backward Compatible Mode Select	Backward Compatible Mode Select to DS90UR905Q and DS90UR907Q. If Reg_02[3] = 1 1: Backward Compatible is on 0: Backward Compatible is off
			1	RW		LFMODE Pin Override	LFMODE Pin Override Enable 1: Use register bit "reg_02[0]" to set LFMODE 0: Use LFMODE Pin
			0	RW		LFMODE	Low Frequency Mode Select 1: PCLK = 5 to <15 MHz 0: PCLK = 15 to 85 MHz

**Register Maps (continued)**
**Table 11. Serial Control Bus Registers (continued)**

ADD (dec)	ADD (hex)	Register Name	Bit(s)	Register Type	Default (hex)	Function	Descriptions
3	0x03	Configuration [1]	7		0xF0		<b>Reserved</b>
			6	RW		CRC Generator Enable	CRC Generator Enable (Back Channel) 1: Enable 0: Disable
			5				<b>Reserved</b>
			4	RW		Filter Enable	HS, VS, DE two clock filter When enabled, pulses less than two full PCLK cycles on the DE, HS, and VS inputs will be rejected 1: Filtering enable 0: Filtering disable
			3	RW		I2C Pass-through	I2C Pass-Through Mode 1: Pass-Through Enabled 0: Pass-Through Disabled
			2	RW		Auto ACK	ACK Select 1: Auto ACK enable 0: Self ACK
			1				<b>Reserved</b>
			0	RW		RRFB	Pixel Clock Edge Select 1: Parallel Interface Data is strobed on the Rising Clock Edge. 0: Parallel Interface Data is strobed on the Falling Clock Edge.
4	0x04	BCC Watchdog Control	7:1	RW	0xFE	BCC Watchdog Timer	The watchdog timer allows termination of a control channel transaction, if it fails to complete within a programmed amount of time. This field sets the Bidirectional Control Channel Watchdog Timeout value in units of 2 milliseconds. This field should not be set to 0
			0	RW		BCC Watchdog Timer Disable	Disable Bidirectional Control Channel Watchdog Timer 1: Disables BCC Watchdog Timer operation 0: Enables BCC Watchdog Timer operation"
5	0x05	I2C Control [1]	7	RW	0x2E	I2C Pass Through All	I2C Pass-Through All Transactions 1: Enabled 0: Disabled
			6:4	RW		I2C SDA Hold Time	Internal I2C SDA Hold Time It configures the amount of internal hold time provided for the SDA input relative to the SCL input. Units are 50 ns.
			3:0	RW		I2C Filter Depth	I2C Glitch Filter Depth It configures the maximum width of glitch pulses on the SCL and SDA inputs that will be rejected. Units are 5 ns.

**Register Maps (continued)**
**Table 11. Serial Control Bus Registers (continued)**

ADD (dec)	ADD (hex)	Register Name	Bit(s)	Register Type	Default (hex)	Function	Descriptions
6	0x06	I2C Control [2]	7	R	0x00	Forward Channel Sequence Error	Control Channel Sequence Error Detected It indicates a sequence error has been detected in forward control channel. It this bit is set, an error may have occurred in the control channel operation.
			6	RW		Clear Sequence Error	It clears the Sequence Error Detect bit This bit is not self-clearing.
			5				<b>Reserved</b>
			4:3	RW		SDA Output Delay	SDA Output Delay This field configures output delay on the SDA output. Setting this value will increase output delay in units of 50 ns. Nominal output delay values for SCL to SDA are: 00 : 250 ns 01: 300 ns 10: 350 ns 11: 400 ns
			2	RW		Local Write	Disable Remote Writes to Local Registers through Serializer (Does not affect remote access to I2C slaves at Deserializer) 1: Stop remote write to local device registers 0: remote write to local device registers
			1	RW		I2C Bus Timer Speed	Speed up I2C Bus Watchdog Timer 1: Timer expires after approximately 50 ms 0: Timer expires after approximately 1 s
			0	RW		I2C Bus Timer Disable	Disable I2C Bus Timer When the I2C Timer may be used to detect when the I2C bus is free or hung up following an invalid termination of a transaction. If SDA is high and no signalling occurs for approximately 1 s, the I2C bus is assumed to be free. If SDA is low and no signaling occurs, the device will try to clear the bus by driving 9 clocks on SCL.
7	0x07	Remote Device ID	7:1	RW	0x18	Remote ID	Remote ID Configures the I2C Slave ID of the remote Serializer. A value of 0 in this field disables I2C access to remote Serializer. This field is automatically configured through the Serializer Forward Channel. Software may overwrite this value, but should also set the FREEZE DEVICE ID bit to prevent overwriting by the Forward Channel.
			0	RW		Freeze Device ID	Freeze Serializer Device ID 1: Prevent auto-loading of the Serializer Device ID from the Forward Channel. The ID will be frozen at the value written. 0: Update
8	0x08	SlaveID[0]	7:1	RW	0x00	Target Slave Device ID0	7-bit Remote Slave Device ID 0 Configures the physical I2C address of the remote I2C Slave device attached to the remote Serializer. If an I2C transaction is addressed to the Slave Alias ID0, the transaction will be remapped to this address before passing the transaction across the Bidirectional Control Channel to the Serializer.
			0				<b>Reserved</b>
9	0x09	SlaveID[1]	7:1	RW	0x00	Target Slave Device ID1	7-bit Remote Slave Device ID 1 Configures the physical I2C address of the remote I2C Slave device attached to the remote Serializer. If an I2C transaction is addressed to the Slave Alias ID1, the transaction will be remapped to this address before passing the transaction across the Bidirectional Control Channel to the Serializer.
			0				<b>Reserved</b>

**Register Maps (continued)**
**Table 11. Serial Control Bus Registers (continued)**

ADD (dec)	ADD (hex)	Register Name	Bit(s)	Register Type	Default (hex)	Function	Descriptions
10	0x0A	SlaveID[2]	7:1	RW	0x00	Target Slave Device ID2	7-bit Remote Slave Device ID 2 Configures the physical I2C address of the remote I2C Slave device attached to the remote Serializer. If an I2C transaction is addressed to the Slave Alias ID2, the transaction will be remapped to this address before passing the transaction across the Bidirectional Control Channel to the Serializer.
			0				<b>Reserved</b>
11	0x0B	SlaveID[3]	7:1	RW	0x00	Target Slave Device ID3	7-bit Remote Slave Device ID 3 Configures the physical I2C address of the remote I2C Slave device attached to the remote Serializer. If an I2C transaction is addressed to the Slave Alias ID3, the transaction will be remapped to this address before passing the transaction across the Bidirectional Control Channel to the Serializer.
			0				<b>Reserved</b>
12	0x0C	SlaveID[4]	7:1	RW	0x00	Target Slave Device ID4	7-bit Remote Slave Device ID 4 Configures the physical I2C address of the remote I2C Slave device attached to the remote Serializer. If an I2C transaction is addressed to the Slave Alias ID4, the transaction will be remapped to this address before passing the transaction across the Bidirectional Control Channel to the Serializer.
			0				<b>Reserved</b>
13	0x0D	SlaveID[5]	7:1	RW	0x00	Target Slave Device ID5	7-bit Remote Slave Device ID 5 Configures the physical I2C address of the remote I2C Slave device attached to the remote Serializer. If an I2C transaction is addressed to the Slave Alias ID5, the transaction will be remapped to this address before passing the transaction across the Bidirectional Control Channel to the Serializer.
			0				<b>Reserved</b>
14	0x0E	SlaveID[6]	7:1	RW	0x00	Target Slave Device ID6	7-bit Remote Slave Device ID 6 Configures the physical I2C address of the remote I2C Slave device attached to the remote Serializer. If an I2C transaction is addressed to the Slave Alias ID6, the transaction will be remapped to this address before passing the transaction across the Bidirectional Control Channel to the Serializer.
			0				<b>Reserved</b>
15	0x0F	SlaveID[7]	7:1	RW	0x00	Target Slave Device ID7	7-bit Remote Slave Device ID 7 Configures the physical I2C address of the remote I2C Slave device attached to the remote Serializer. If an I2C transaction is addressed to the Slave Alias ID7, the transaction will be remapped to this address before passing the transaction across the Bidirectional Control Channel to the Serializer.
			0				<b>Reserved</b>
16	0x10	SlaveAlias[0]	7:1	RW	0x00	ID[0] Match	7-bit Remote Slave Device Alias ID 0 Configures the decoder for detecting transactions designated for an I2C Slave device attached to the remote Serializer. The transaction will be remapped to the address specified in the Slave ID0 register. A value of 0 in this field disables access to the remote I2C Slave.
			0				<b>Reserved</b>

**Register Maps (continued)**
**Table 11. Serial Control Bus Registers (continued)**

ADD (dec)	ADD (hex)	Register Name	Bit(s)	Register Type	Default (hex)	Function	Descriptions
17	0x11	SlaveAlias[1]	7:1	RW	0x00	ID[1] Match	7-bit Remote Slave Device Alias ID 1 Configures the decoder for detecting transactions designated for an I2C Slave device attached to the remote Serializer. The transaction will be remapped to the address specified in the Slave ID1 register. A value of 0 in this field disables access to the remote I2C Slave.
			0				<b>Reserved</b>
18	0x12	SlaveAlias[2]	7:1	RW	0x00	ID[2] Match	7-bit Remote Slave Device Alias ID 2 Configures the decoder for detecting transactions designated for an I2C Slave device attached to the remote Serializer. The transaction will be remapped to the address specified in the Slave ID2 register. A value of 0 in this field disables access to the remote I2C Slave.
			0				<b>Reserved</b>
19	0x13	SlaveAlias[3]	7:1	RW	0x10	ID[3] Match	7-bit Remote Slave Device Alias ID 3 Configures the decoder for detecting transactions designated for an I2C Slave device attached to the remote Serializer. The transaction will be remapped to the address specified in the Slave ID3 register. A value of 0 in this field disables access to the remote I2C Slave.
			0				<b>Reserved</b>
20	0x14	SlaveAlias[4]	7:1	RW	0x00	ID[4] Match	7-bit Remote Slave Device Alias ID 4 Configures the decoder for detecting transactions designated for an I2C Slave device attached to the remote Serializer. The transaction will be remapped to the address specified in the Slave ID4 register. A value of 0 in this field disables access to the remote I2C Slave.
			0				<b>Reserved</b>
21	0x15	SlaveAlias[5]	7:1	RW	0x00	ID[5] Match	7-bit Remote Slave Device Alias ID 5 Configures the decoder for detecting transactions designated for an I2C Slave device attached to the remote Serializer. The transaction will be remapped to the address specified in the Slave ID5 register. A value of 0 in this field disables access to the remote I2C Slave.
			0				<b>Reserved</b>
22	0x16	SlaveAlias[6]	7:1	RW	0x00	ID[6] Match	7-bit Remote Slave Device Alias ID 6 Configures the decoder for detecting transactions designated for an I2C Slave device attached to the remote Serializer. The transaction will be remapped to the address specified in the Slave ID6 register. A value of 0 in this field disables access to the remote I2C Slave.
			0	RW			<b>Reserved</b>
23	0x17	SlaveAlias[7]	7:1	RW	0x00	ID[7] Match	7-bit Remote Slave Device Alias ID 7 Configures the decoder for detecting transactions designated for an I2C Slave device attached to the remote Serializer. The transaction will be remapped to the address specified in the Slave ID7 register. A value of 0 in this field disables access to the remote I2C Slave.
			0				<b>Reserved</b>

**Register Maps (continued)**
**Table 11. Serial Control Bus Registers (continued)**

ADD (dec)	ADD (hex)	Register Name	Bit(s)	Register Type	Default (hex)	Function	Descriptions
28	0x1C	General Status	7:4	RW	0x00		<b>Reserved</b>
			3	R		I2S Locked	I2S Lock Status 0: I2S PLL controller not locked 1: I2S PLL controller locked to input I2S clock
			2				<b>Reserved</b>
			1				<b>Reserved</b>
			0	R		Lock	Deserializer CDR, PLL's clock to recovered clock frequency 1: Deserializer locked to recovered clock 0: Deserializer not locked
29	0x1D	GPIO0 Config	7:4	R	0xA0	Rev-ID	Revision ID: 1010: Production Device
			3	RW		GPIO0 Output Value	Local GPIO Output Value This value is output on the GPIO pin when the GPIO function is enabled, the local GPIO direction is Output, and remote GPIO control is disabled.
			2	RW		GPIO0 Remote Enable	Remote GPIO0 Control 1: Enable GPIO control from remote Serializer. The GPIO pin will be an output, and the value is received from the remote Deserializer. 0: Disable GPIO control from remote Serializer
			1	RW		GPIO0 Direction	Local GPIO Direction 1: Input 0: Output
			0	RW		GPIO0 Enable	GPIO Function Enable 1: Enable GPIO operation 0: Enable normal operation
30	0x1E	GPIO2 and GPIO1 Config	7	RW	0x00	GPIO2 Output Value	Local GPIO Output Value This value is output on the GPIO when the GPIO function is enabled, the local GPIO direction is Output, and remote GPIO control is disabled.
			6	RW		GPIO2 Remote Enable	Remote GPIO2 Control 1: Enable GPIO control from remote Serializer. The GPIO pin will be an output, and the value is received from the remote Deserializer. 0: Disable GPIO control from remote Serializer.
			5	RW		GPIO2 Direction	Local GPIO Direction 1: Input 0: Output
			4	RW		GPIO2 Enable	GPIO Function Enable 1: Enable GPIO operation 0: Enable normal operation
			3	RW		GPIO1 Output Value	Local GPIO Output Value This value is output on the GPIO when the GPIO function is enabled, the local GPIO direction is Output, and remote GPIO control is disabled.
			2	RW		GPIO1 Remote Enable	Remote GPIO1 Control 1: Enable GPIO control from remote Serializer. The GPIO pin will be an output, and the value is received from the remote Deserializer. 0: Disable GPIO control from remote Serializer.
			1	RW		GPIO1 Direction	Local GPIO Direction 1: Input 0: Output
			0	RW		GPIO1 Enable	GPIO Function Enable 1: Enable GPIO operation 0: Enable normal operation

**Register Maps (continued)**
**Table 11. Serial Control Bus Registers (continued)**

ADD (dec)	ADD (hex)	Register Name	Bit(s)	Register Type	Default (hex)	Function	Descriptions
31	0x1F	GPO_REG4 and GPO3 Config	7	RW	0x00	GPO_REG4 Output Value	Local GPO_REG4 Output Value This value is output on the GPO when the GPO function is enabled, the local GPO direction is Output, and remote GPO control is disabled.
			6:5			<b>Reserved</b>	
			4	RW		GPO_REG4 Enable	GPO_REG4 Function Enable 1: Enable GPO operation 0: Enable normal operation
			3	RW		GPIO3 Output Value	Local GPIO Output Value This value is output on the GPIO when the GPIO function is enabled, the local GPIO direction is Output, and remote GPIO control is disabled.
			2	RW		GPIO3 Remote Enable	Remote GPIO3 Control 1: Enable GPIO control from remote Serializer. The GPIO pin will be an output, and the value is received from the remote Deserializer. 0: Disable GPIO control from remote Serializer.
			1	RW		GPIO3 Direction	Local GPIO Direction 1: Input 0: Output
			0	RW		GPIO3 Enable	GPIO Function Enable 1: Enable GPIO operation 0: Enable normal operation
32	0x20	GPO_REG6 and GPO_REG5 Config	7	RW	0x00	GPO_REG6 Output Value	Local GPO_REG6 Output Value This value is output on the GPO when the GPO function is enabled, the local GPO direction is Output, and remote GPO control is disabled.
			6:5			<b>Reserved</b>	
			4	RW		GPO_REG6 Enable	GPO_REG6 Function Enable 1: Enable GPO operation 0: Enable normal operation
			3	RW		GPO_REG5 Output Value	Local GPO_REG5 Output Value This value is output on the GPO when the GPO function is enabled, the local GPO direction is Output, and remote GPO control is disabled.
			2:1			<b>Reserved</b>	
			0	RW		GPO_REG5 Enable	GPO_REG5 Function Enable 1: Enable GPO operation 0: Enable normal operation
33	0x21	GPO8 and GPO7 Config	7	RW	0x00	GPO_REG8 Output Value	Local GPO_REG8 Output Value This value is output on the GPO when the GPO function is enabled, the local GPO direction is Output, and remote GPO control is disabled.
			6:5			<b>Reserved</b>	
			4	RW		GPO_REG8 Enable	GPO_REG8 Function Enable 1: Enable GPO operation 0: Enable normal operation
			3	RW		GPO_REG7 Output Value	Local GPO_REG7 Output Value This value is output on the GPO when the GPO function is enabled, the local GPO direction is Output, and remote GPO control is disabled.
			2:1			<b>Reserved</b>	
			0	RW		GPO_REG7 Enable	GPO_REG7 Function Enable 1: Enable GPO operation 0: Enable normal operation

**Register Maps (continued)**
**Table 11. Serial Control Bus Registers (continued)**

ADD (dec)	ADD (hex)	Register Name	Bit(s)	Register Type	Default (hex)	Function	Descriptions
34	0x22	Data Path Control	7	RW	0x00	Override FC Config	1: Disable loading of this register from the forward channel, keeping locally written values intact 0: Allow forward channel loading of this register
			6	RW		Pass RGB	Setting this bit causes RGB data to be sent independent of DE. This allows operation in systems which may not use DE to frame video data or send other data when DE is deasserted. Note that setting this bit blocks packetized audio. This bit does not need to be set in DS90UB925 or in Backward Compatibility mode. 1: Pass RGB independent of DE 0: Normal operation Note: this bit is automatically loaded from the remote serializer unless bit 7 of this register is set.
			5	RW		DE Polarity	This bit indicates the polarity of the DE (Data Enable) signal. 1: DE is inverted (active low, idle high) 0: DE is positive (active high, idle low) Note: this bit is automatically loaded from the remote serializer unless bit 7 of this register is set.
			4	RW		I2S_Gen	This bit controls whether the Receiver outputs packetized Auxiliary/Audio data on the RGB video output pins. 1: Don't output packetized audio data on RGB video output pins 0: Output packetized audio on RGB video output pins. Note: this bit is automatically loaded from the remote serializer unless bit 7 of this register is set.
			3	RW		I2S Channel B Enable Override	1: Set I2S Channel B Enable from reg_22[0] 0: Set I2S Channel B Enable from MODE_SEL pin Note: this bit is automatically loaded from the remote serializer unless bit 7 of this register is set.
			2	RW		18-bit Video Select	1: Select 18-bit video mode 0: Select 24-bit video mode Note: this bit is automatically loaded from the remote serializer unless bit 7 of this register is set.
			1	RW		I2S Transport Select	1: Enable I2S Data Forward Channel Frame Transport 0: Enable I2S Data Island Transport Note: this bit is automatically loaded from the remote serializer unless bit 7 of this register is set.
			0	RW		I2S Channel B Enable	I2S Channel B Enable 1: Enable I2S Channel B on B1 output 0: I2S Channel B disabled Note: this bit is automatically loaded from the remote serializer unless bit 7 of this register is set.
			35	0x23		General Purpose Control	7
6:5		<b>Reserved</b>					
4	R	Mode_Sel			Mode Select is Done		
3	R	LFMODE			Low Frequency Mode Status		
2	R	Repeater			Repeater Mode Status		
1	R	Backward			Backward Compatible Mode Status		
0	R	I2S Channel B			I2S Channel B Status		

**Register Maps (continued)**
**Table 11. Serial Control Bus Registers (continued)**

ADD (dec)	ADD (hex)	Register Name	Bit(s)	Register Type	Default (hex)	Function	Descriptions
36	0x24	BIST Control	7:4		0x08		<b>Reserved</b>
			3	RW		BIST Pin Config	BIST Configured through Pin 1: BIST configured through pin 0: BIST configured through register bit
			2:1	RW		BIST Clock Source	BIST Clock Source 00: External Pixel Clock 01: 33 MHz Oscillator 10: Reserved 11: 25 MHz Oscillator
			0	RW		BIST Enable	BIST Control 1: Enabled 0: Disabled
37	0x25	BIST Error	7:0	R	0x00	BIST Error Count	BIST Error Count
38	0x26	SCL High Time	7:0	RW	0x83	SCL High Time	I2C Master SCL High Time This field configures the high pulse width of the SCL output when the Deserializer is the Master on the local I2C bus. Units are 50 ns for the nominal oscillator clock frequency. The default value is set to provide a minimum 5µs SCL high time with the internal oscillator clock running at 26 MHz rather than the nominal 20 MHz.
39	0x27	SCL Low Time	7:0	RW	0x84	SCL Low Time	I2C SCL Low Time This field configures the low pulse width of the SCL output when the De-Serializer is the Master on the local I2C bus. This value is also used as the SDA setup time by the I2C Slave for providing data prior to releasing SCL during accesses over the Bidirectional Control Channel. Units are 50 ns for the nominal oscillator clock frequency. The default value is set to provide a minimum 5µs SCL low time with the internal oscillator clock running at 26 MHz rather than the nominal 20 MHz.
41	0x29	FRC Control	7	RW	0x00	Timing Mode Select	Select display timing mode 0: DE only Mode 1: Sync Mode (VS,HS)
			6	RW		VS Polarity	0: Active High 1: Active Low
			5	RW		HS Polarity	0: Active High 1: Active Low
			4	RW		DE Polarity	0: Active High 1: Active Low
			3	RW		FRC2 Enable	0: FRC2 Disable 1: FRC2 Enable
			2	RW		FRC1 Enable	0: FRC1 Disable 1: FRC1 Enable
			1	RW		Hi-FRC 2 Disable	0: Hi-FRC2 Enable 1: Hi-FRC2 Disable
			0	RW		Hi-FRC 1 Disable	0: Hi-FRC1 Enable 1: Hi-FRC1 Disable
42	0x2A	White Balance Control	7:6	RW	0x00	Page Setting	00: Configuration Registers 01: Red LUT 10: Green LUT 11: Blue LUT
			5	RW		White Balance Enable	0: White Balance Disable 1: White Balance Enable
			4	RW		LUT Reload Enable	0: Reload Disable 1: Reload Enable
			3:0				<b>Reserved</b>

**Register Maps (continued)**
**Table 11. Serial Control Bus Registers (continued)**

ADD (dec)	ADD (hex)	Register Name	Bit(s)	Register Type	Default (hex)	Function	Descriptions
43	0x2B	I2S Control	7	RW	0x00	I2S PLL	I2S PLL Control 0: I2S PLL is on for I2S data jitter cleaning 1: I2S PLL is off. No jitter cleaning
			6:1				<b>Reserved</b>
			0	RW		I2S Clock Edge	I2S Clock Edge Select 0: I2S Data is strobed on the Rising Clock Edge 1: I2S Data is strobed on the Falling Clock Edge
44	0x2C	SSCG Control	7:4		0x00		<b>Reserved</b>
			3	RW		SSCG Enable	Enable Spread Spectrum Clock Generator 0: Disable 1: Enable
			2:0	RW		SSCG Selection	SSCG Frequency Deviation: When LFMODE = H fdev fmod 000: ±0.7 CLK/628 001: ±1.3 010: ±1.8 011: ±2.5 100: ±0.7 CLK/388 101: ±1.2 110: ±2 111: ±2.5 When LFMODE = L fdev fmod 000: ±0.9 CLK/2168 001: ±1.2 010: ±1.9 011: ±2.5 100: ±0.7 CLK/1300 101: ±1.3 110: ±2 111: ±2.5
58	0x3A	I2S MCLK Output	7	RW	0x00	MCLK Override	1: Override divider select for MCLK 0: No override for MCLK divider
			6:4	RW		MCLK Frequency Select	See <a href="#">Table 5</a>
			3:0				<b>Reserved</b>
65	0x41	Link Error Count	7:5		0x03		<b>Reserved</b>
			4	RW		Link Error Count Enable	Enable serial link data integrity error count 1: Enable error count 0: Disable
			3:0	RW		Link Error Count	Link error count threshold. Counter is pixel clock based. clk0, clk1 and DCA are monitored for link errors, if error count is enabled, deserializer loose lock once error count reaches threshold. If disabled deserializer loose lock with one error.

**Register Maps (continued)**
**Table 11. Serial Control Bus Registers (continued)**

ADD (dec)	ADD (hex)	Register Name	Bit(s)	Register Type	Default (hex)	Function	Descriptions
68	0x44	Equalization	7:5	RW	0x60	EQ Stage 1 Select	EQ select value. Used if adaptive EQ is bypassed. 000 Min EQ 1st Stage 001 010 011 100 101 110 111 Max EQ 1st Stage
			4				<b>Reserved</b>
			3:1	RW		EQ Stage 2 Select	EQ select value. Used if adaptive EQ is bypassed. 000 Min EQ 2nd Stage 001 010 011 100 101 110 111 Max EQ 2nd Stage
			0	RW		Adaptive EQ	1: Disable adaptive EQ (to write EQ select values) 0: Enable adaptive EQ
86	0x56	CML Output	7:4		0x08		<b>Reserved</b>
			3	RW		CMLOUT+/- Enable	1: Disabled (Default) 0: Enabled
			2:0				<b>Reserved</b>
100	0x64	Pattern Generator Control	7:4	RW	0x10	Pattern Generator Select	Fixed Pattern Select This field selects the pattern to output when in Fixed Pattern Mode. Scaled patterns are evenly distributed across the horizontal or vertical active regions. This field is ignored when Auto-Scrolling Mode is enabled. The following table shows the color selections in non-inverted followed by inverted color mode 0000: Reserved 0001: White/Black 0010: Black/White 0011: Red/Cyan 0100: Green/Magenta 0101: Blue/Yellow 0110: Horizontally Scaled Black to White/White to Black 0111: Horizontally Scaled Black to Red/Cyan to White 1000: Horizontally Scaled Black to Green/Magenta to White 1001: Horizontally Scaled Black to Blue/Yellow to White 1010: Vertically Scaled Black to White/White to Black 1011: Vertically Scaled Black to Red/Cyan to White 1100: Vertically Scaled Black to Green/Magenta to White 1101: Vertically Scaled Black to Blue/Yellow to White 1110: Custom color (or its inversion) configured in PGRS, PGGs, PGBs registers 1111: Reserved
			3:1				<b>Reserved</b>
			0	RW		Pattern Generator Enable	1: Enable Pattern Generator 0: Disable Pattern Generator

**Register Maps (continued)**
**Table 11. Serial Control Bus Registers (continued)**

ADD (dec)	ADD (hex)	Register Name	Bit(s)	Register Type	Default (hex)	Function	Descriptions
101	0x65	Pattern Generator Configuration	7:5		0x00		<b>Reserved</b>
			4	RW		Pattern Generator 18 Bits	18-bit Mode Select 1: Enable 18-bit color pattern generation. Scaled patterns will have 64 levels of brightness and the R, G, and B outputs use the six most significant color bits. 0: Enable 24-bit pattern generation. Scaled patterns use 256 levels of brightness.
			3	RW		Pattern Generator External Clock	Select External Clock Source 1: Selects the external pixel clock when using internal timing. 0: Selects the internal divided clock when using internal timing This bit has no effect in external timing mode (PATGEN_TSEL = 0).
			2	RW		Pattern Generator Timing Select	Timing Select Control 1: The Pattern Generator creates its own video timing as configured in the Pattern Generator Total Frame Size, Active Frame Size, Horizontal Sync Width, Vertical Sync Width, Horizontal Back Porch, Vertical Back Porch, and Sync Configuration registers. 0: the Pattern Generator uses external video timing from the pixel clock, Data Enable, Horizontal Sync, and Vertical Sync signals.
			1	RW		Pattern Generator Color Invert	Enable Inverted Color Patterns 1: Invert the color output. 0: Do not invert the color output.
			0	RW		Pattern Generator Auto-Scroll Enable	Auto-Scroll Enable: 1: The Pattern Generator will automatically move to the next enabled pattern after the number of frames specified in the Pattern Generator Frame Time (PGFT) register. 0: The Pattern Generator retains the current pattern.
102	0x66	Pattern Generator Indirect Address	7:0	RW	0x00	Indirect Address	This 8-bit field sets the indirect address for accesses to indirectly-mapped registers. It should be written prior to reading or writing the Pattern Generator Indirect Data register. <a href="#">See AN-2198 Exploring Int Test Patt Gen Feat of 720p FPD-Link III Devices (SNLA132)</a>
103	0x67	Pattern Generator Indirect Data	7:0	RW	0x00	Indirect Data	When writing to indirect registers, this register contains the data to be written. When reading from indirect registers, this register contains the read back value. <a href="#">See AN-2198 Exploring Int Test Patt Gen Feat of 720p FPD-Link III Devices (SNLA132)</a>
240	0xF0	RX ID	7:0	R	0x5F	ID0	First byte ID code: _
241	0xF1		7:0	R	0x55	ID1	Second byte of ID code: U
242	0xF2		7:0	R	0x48	ID2	Third byte of ID code, Value will be either B.
243	0xF3		7:0	R	0x39	ID3	Fourth byte of ID code: 9
244	0xF4		7:0	R	0x32	ID4	Fifth byte of ID code: 2
245	0xF5		7:0	R	0x36	ID5	Sixth byte of ID code: 6

## 9 Application and Implementation

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### NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

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### 9.1 Application Information

The DS90UB926Q-Q1, in conjunction with the DS90UB925Q-Q1, is intended for interface between a host (graphics processor) and a display. It supports an 24-bit color depth (RGB888) and high definition (720p) digital video format. The device allows to receive a three 8-bit RGB stream with a pixel rate up to 85 MHz together with three control bits (VS, HS and DE) and three I2S-bus audio stream with an audio sampling rate up to 192 kHz.

#### 9.1.1 Display Application

The deserializer is expected to be located close to its target device. The interconnect between the deserializer and the target device is typically in the 1-inch to 3-inch separation range. The input capacitance of the target device is expected to be in the 5- to 10-pF range. Care should be taken on the PCLK output trace as this signal is edge sensitive and strobes the data. It is also assumed that the fanout of the deserializer is up to three in the repeater mode. If additional loads need to be driven, TI recommends a logic buffer or multiplexer (mux) device.

9.2 Typical Application

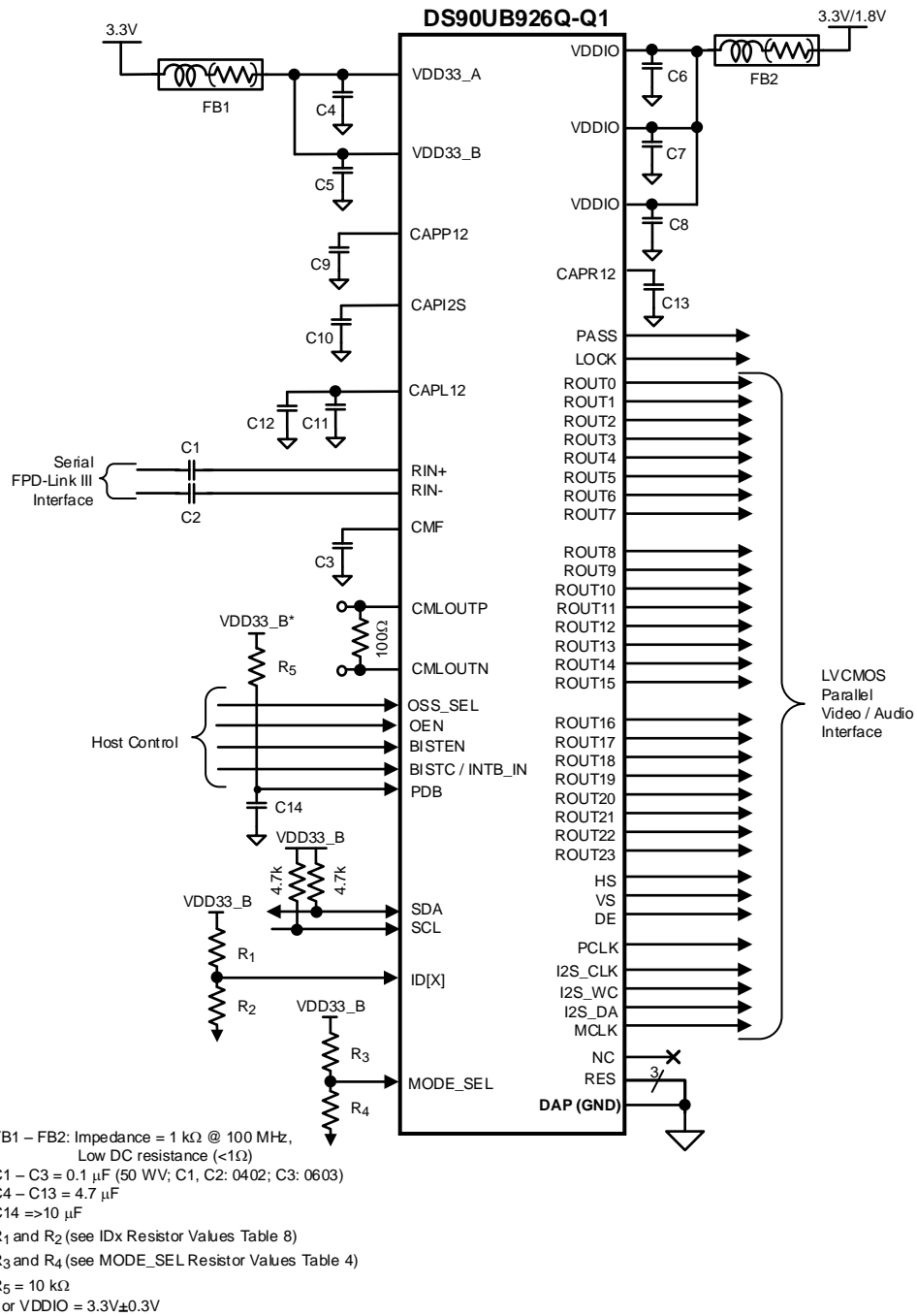


Figure 24. Typical Connection Diagram

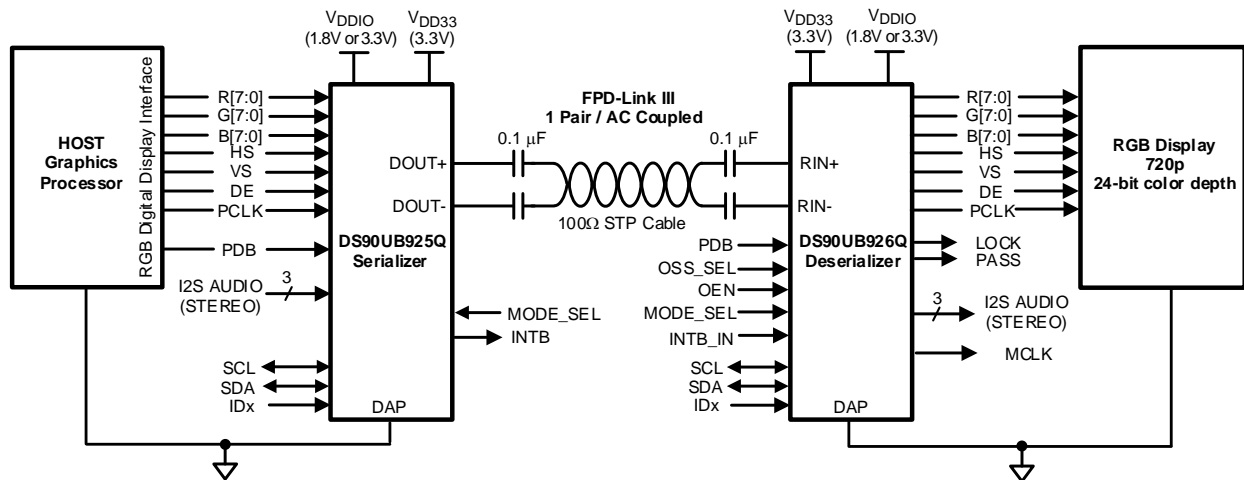
**Typical Application (continued)**

**Figure 25. Typical Display System Diagram**

Figure 24 shows a typical application of the DS90UB926Q-Q1 deserializer for an 85 MHz, 24-bit color display application. Inputs use 0.1- $\mu$ F coupling capacitors to the line and the deserializer provides internal termination. Bypass capacitors are placed near the power supply pins. At a minimum, seven 0.1- $\mu$ F capacitors and two 4.7- $\mu$ F capacitors should be used for local device bypassing. Ferrite beads are placed on the power lines for effective noise suppression. Since the device is in the Pin/STRAP mode, two 10-k $\Omega$  pullup resistors are used on the parallel output bus to select the desired device features.

The interface to the target display is with 3.3-V LVCMOS levels, thus the  $V_{DDIO}$  pins are connected to the 3.3-V rail. A delay cap is placed on the PDB signal to delay the enabling of the device until power is stable.

**9.2.1 Design Requirements**

For the typical design application, use the following as input parameters.

**Table 12. Design Parameters**

DESIGN PARAMETER	EXAMPLE VALUE
VDDIO	1.8 V or 3.3 V
VDD33	3.3 V
AC-coupling capacitor for RIN $\pm$	100 nF
PCLK frequency	78 MHz

**9.2.2 Detailed Design Procedure**
**9.2.2.1 Transmission Media**

The DS90UB925Q-Q1 and DS90UB926Q-Q1 chipset is intended to be used in a point-to-point configuration through a shielded twisted pair cable. The serializer and deserializer provide internal termination to minimize impedance discontinuities. The interconnect (cable and connector) between the serializer and deserializer should have a differential impedance of 100  $\Omega$ . The maximum length of cable that can be used is dependant on the quality of the cable (gauge, impedance), connector, board (discontinuities, power plane), the electrical environment (for example, power stability, ground noise, input clock jitter, PCLK frequency, etc.) and the application environment.

The resulting signal quality at the receiving end of the transmission media may be assessed by monitoring the differential eye opening of the serial data stream. The Receiver CML Monitor Driver Output Specifications define the acceptable data eye-opening width and eye-opening height. A differential probe should be used to measure across the termination resistor at the CMLOUTP/N pin [Figure 2](#).

### 9.2.3 Application Curves

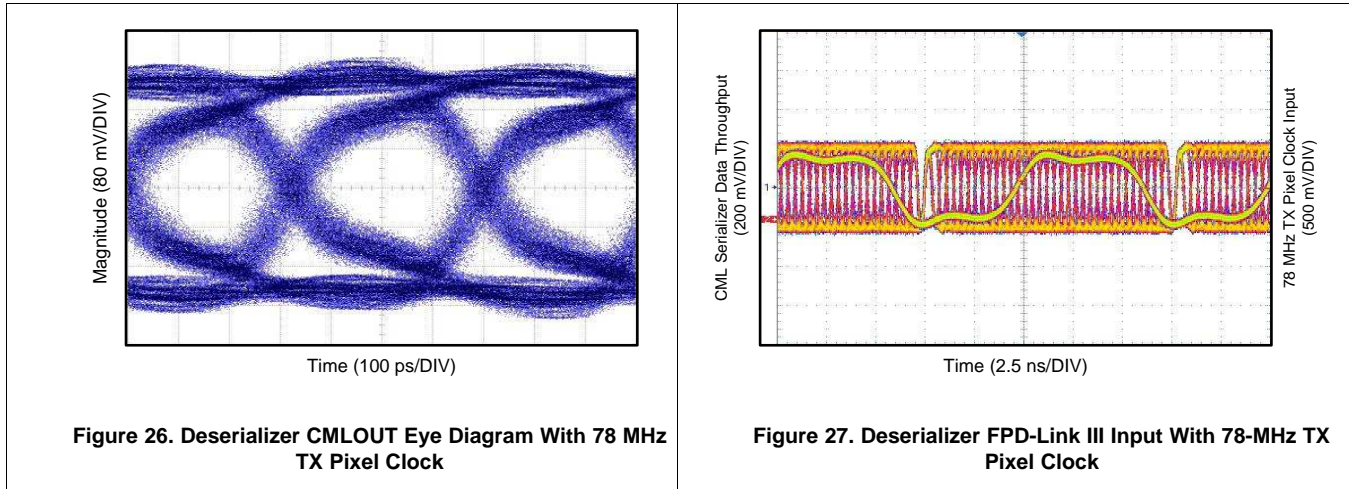


Figure 26. Deserializer CMLOUT Eye Diagram With 78 MHz TX Pixel Clock

Figure 27. Deserializer FPD-Link III Input With 78-MHz TX Pixel Clock

## 10 Power Supply Recommendations

### 10.1 Power Up Requirements and PDB Pin

When VDDIO and VDD33\_X are powered separately, the VDDIO supply (1.8 V or 3.3 V) must ramp 100  $\mu$ s before the other supply (VDD33\_X) begins to ramp. If VDDIO is tied with VDD33\_X, both supplies may ramp at the same time. The VDDs (VDD33\_X and VDDIO) supply ramp must be faster than 1.5 ms with a monotonic rise. A large capacitor on the PDB pin is required to ensure PDB arrives after all the VDDs have settled to the recommended operating voltage. When PDB pin is pulled to VDDIO = 3 V to 3.6 V or VDD33\_X, TI recommends using a 10-k $\Omega$  pullup and a > 10- $\mu$ F capacitor to GND to delay the PDB input signal.

All inputs must not be driven until VDD33\_X and VDDIO has reached its steady-state value.

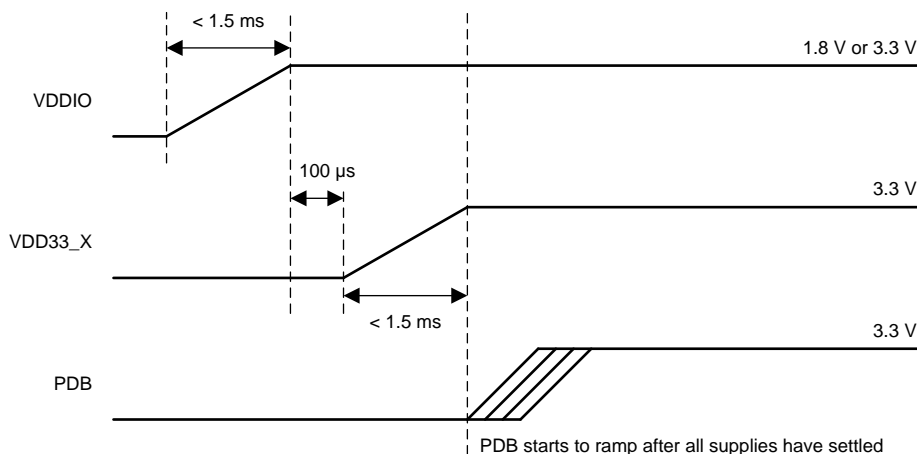


Figure 28. Power-Up Sequence of DS90UB926Q-Q1

## 11 Layout

### 11.1 Layout Guidelines

Design the circuit board layout and stack-up for the FPD-Link III devices to provide low-noise power feed to the device. Good layout practice separates high frequency or high-level inputs and outputs to minimize unwanted stray noise pickup, feedback, and interference. Power system performance may be greatly improved by using thin dielectrics (2 to 4 mils) for power / ground sandwiches. This arrangement provides plane capacitance for the PCB power system with low-inductance parasitics, which has proven especially effective at high frequencies, and makes the value and placement of external bypass capacitors less critical. External bypass capacitors should include both RF ceramic and tantalum electrolytic types. RF capacitors may use values in the range of 0.01  $\mu\text{F}$  to 0.1  $\mu\text{F}$ . Tantalum capacitors may be in the 2.2- $\mu\text{F}$  to 10- $\mu\text{F}$  range. Voltage rating of the tantalum capacitors should be at least 5x the power supply voltage being used.

TI recommends surface-mount capacitors due to their smaller parasitics. When using multiple capacitors per supply pin, locate the smaller value closer to the pin. A large bulk capacitor is recommend at the point of power entry. This is typically in the 50- $\mu\text{F}$  to 100- $\mu\text{F}$  range and will smooth low-frequency switching noise. TI recommends connecting power and ground pins directly to the power and ground planes with bypass capacitors connected to the plane with via on both ends of the capacitor. Connecting power or ground pins to an external bypass capacitor increases the inductance of the path.

TI recommends a small body size X7R chip capacitor, such as 0603 or 0402, for external bypass. Its small body size reduces the parasitic inductance of the capacitor. The user must pay attention to the resonance frequency of these external bypass capacitors, usually in the range of 20 to 30 MHz. To provide effective bypassing, multiple capacitors are often used to achieve low impedance between the supply rails over the frequency of interest. At high frequency, it is also a common practice to use two vias from power and ground pins to the planes, reducing the impedance at high frequency.

Some devices provide separate power and ground pins for different portions of the circuit. This is done to isolate switching noise effects between different sections of the circuit. Separate planes on the PCB are typically not required. Pin description tables typically provide guidance on which circuit blocks are connected to which power pin pairs. In some cases, an external filter may be used to provide clean power to sensitive circuits such as PLLs.

Use at least a four layer board with a power and ground plane. Locate LVCMOS signals away from the CML lines to prevent coupling from the LVCMOS lines to the CML lines. Closely-coupled differential lines of 100  $\Omega$  are typically recommended for CML interconnect. The closely coupled lines help to ensure that coupled noise appears as common-mode and thus is rejected by the receivers. The tightly coupled lines will also radiate less.

Information on the WQFN style package is provided in [AN-1187 Leadless Leadframe Package \(LLP\)](#) (SNOA401).

Stencil parameters such as aperture area ratio and the fabrication process have a significant impact on paste deposition. Inspection of the stencil prior to placement of the WQFN package is highly recommended to improve board assembly yields. If the via and aperture openings are not carefully monitored, the solder may flow unevenly through the DAP. Stencil parameters for aperture opening and via locations are shown in [Table 13](#):

**Table 13. No Pullback WQFN Stencil Aperture Summary**

DEVICE	PIN COUNT	MKT DWG	PCB I/O PAD SIZE (mm)	PCB PITCH (mm)	PCB DAP SIZE (mm)	STENCIL I/O APERTURE (mm)	STENCIL DAP APERTURE (mm)	NUMBER of DAP APERTURE OPENINGS
DS90UB926Q-Q1	60	NKB0060B	0.25 x 0.6	0.5	6.3 x 6.3	0.25 x 0.8	6.3 x 6.3	1

[Figure 29](#) shows the PCB layout example derived from the layout design of the DS90UB926QSEVB evaluation board. The graphic and layout description are used to determine both proper routing and proper solder techniques when designing the Serializer board.

### 11.1.1 CML Interconnect Guidelines

See [Application Note 1108 Channel-Link PCB and Interconnect Design-In Guidelines](#) (SNLA008) and [AN-905 Transmission Line RAPIDESIGNER Operation and Applications Guide](#) (SNLA035) for full details.

- Use 100- $\Omega$  coupled differential pairs
- Use the S/2S/3S rule in spacings
  - S = space between the pair
  - 2S = space between pairs
  - 3S = space to LVCMOS signal
- Minimize the number of Vias
- Use differential connectors when operating above 500-Mbps line speed
- Maintain balance of the traces
- Minimize skew within the pair

Additional general guidance can be found in the LVDS Owner's Manual - available in PDF format from the TI web site at: [www.ti.com/lvds](http://www.ti.com/lvds).

## 11.2 Layout Examples

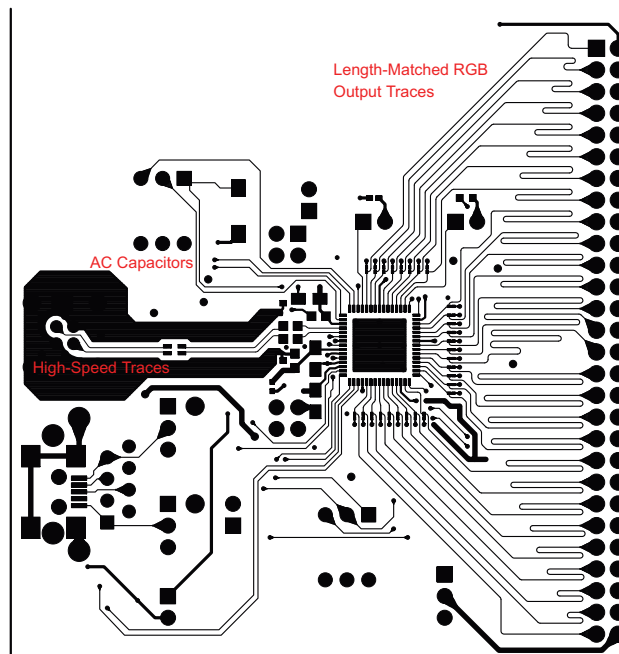


Figure 29. DS90UB926Q-Q1 Serializer Example Layout

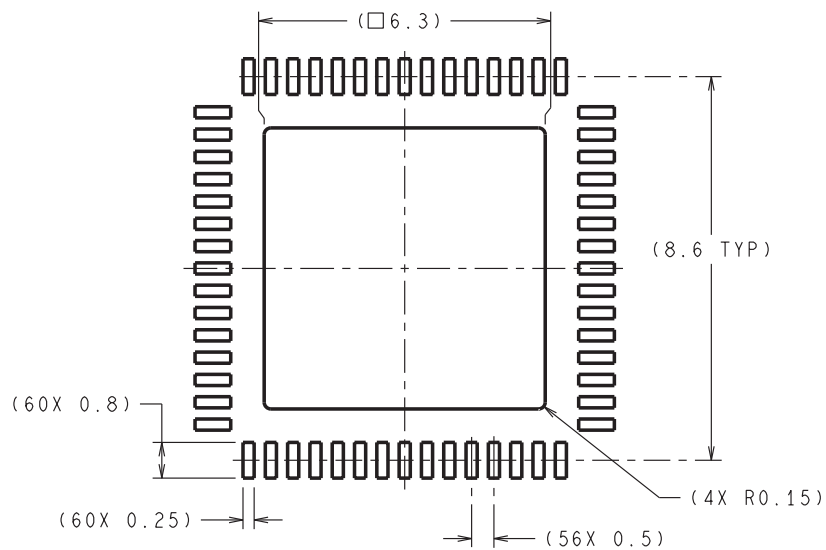


Figure 30. 60-Pin WQFN Stencil Example of Via and Opening Placement

## 12 器件和文档支持

### 12.1 文档支持

#### 12.1.1 相关文档

请参阅如下相关文档：

- 《AN-1108 通道链路 PCB 和互连设计指南》(SNLA008)
- 《AN-905 传输线路 RAPIDESIGNER 操作和 应用 指南》(SNLA035)
- 《AN-1187 无引线框架封装 (LLP)》(SNOA401)
- 《LVDS 所有者手册》(文献编号：SNLA187)

### 12.2 接收文档更新通知

要接收文档更新通知，请导航至德州仪器 TI.com.cn 上的器件产品文件夹。请单击右上角的通知我 进行注册，即可收到任意产品信息更改每周摘要。有关更改的详细信息，请查看任意已修订文档中包含的修订历史记录。

### 12.3 社区资源

下列链接提供到 TI 社区资源的连接。链接的内容由各个分销商“按照原样”提供。这些内容并不构成 TI 技术规范，并且不一定反映 TI 的观点；请参阅 TI 的《使用条款》。

**TI E2E™ 在线社区** TI 的工程师对工程师 (E2E) 社区。此社区的创建目的在于促进工程师之间的协作。在 e2e.ti.com 中，您可以咨询问题、分享知识、拓展思路并与同行工程师一道帮助解决问题。

**设计支持** TI 参考设计支持 可帮助您快速查找有帮助的 E2E 论坛、设计支持工具以及技术支持的联系信息。

### 12.4 商标

E2E is a trademark of Texas Instruments.  
All other trademarks are the property of their respective owners.

### 12.5 静电放电警告



这些装置包含有限的内置 ESD 保护。存储或装卸时，应将导线一起截短或将装置放置于导电泡棉中，以防止 MOS 门极遭受静电损伤。

### 12.6 Glossary

**SLYZ022** — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

## 13 机械、封装和可订购信息

以下页面包括机械、封装和可订购信息。这些信息是指定器件的最新可用数据。这些数据发生变化时，我们可能不会另行通知或修订此文档。如欲获取此产品说明书的浏览器版本，请参阅左侧的导航栏。

**PACKAGING INFORMATION**

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
DS90UB926QSQ/NOPB	ACTIVE	WQFN	NKB	60	1000	RoHS & Green	NIPDAU   SN	Level-3-260C-168 HR	-40 to 105	UB926QSQ	<a href="#">Samples</a>
DS90UB926QSQE/NOPB	ACTIVE	WQFN	NKB	60	250	RoHS & Green	NIPDAU   SN	Level-3-260C-168 HR	-40 to 105	UB926QSQ	<a href="#">Samples</a>
DS90UB926QSQX/NOPB	ACTIVE	WQFN	NKB	60	2000	RoHS & Green	SN	Level-3-260C-168 HR	-40 to 105	UB926QSQ	<a href="#">Samples</a>

(1) The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSELETE:** TI has discontinued the production of the device.

(2) **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

**RoHS Exempt:** TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

**Green:** TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

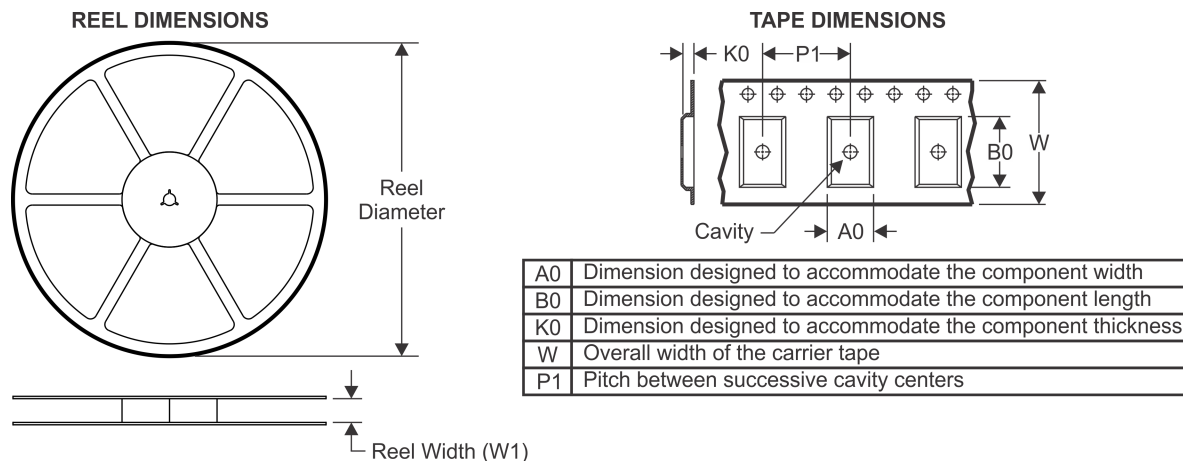
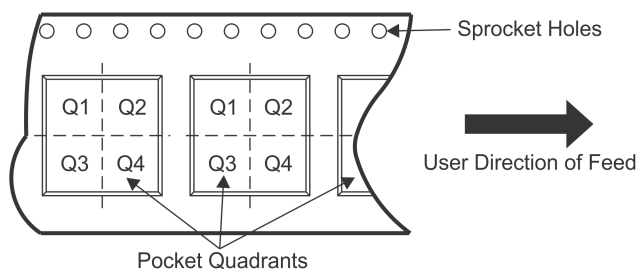
(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

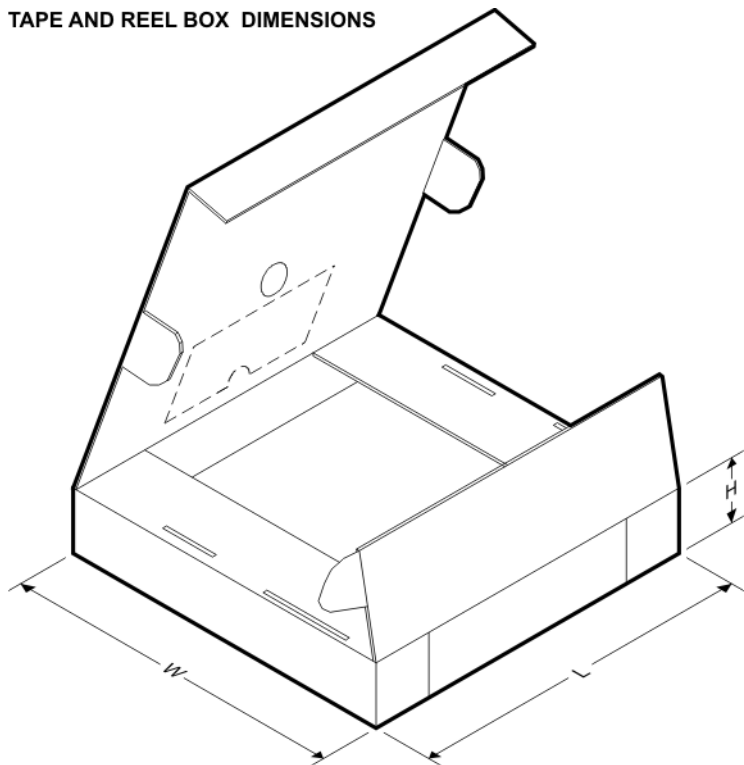
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**TAPE AND REEL INFORMATION**

**QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE**


\*All dimensions are nominal

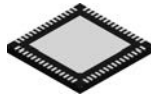
Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
DS90UB926QSQ/NOPB	WQFN	NKB	60	1000	330.0	16.4	9.3	9.3	1.3	12.0	16.0	Q1
DS90UB926QSQE/NOPB	WQFN	NKB	60	250	178.0	16.4	9.3	9.3	1.3	12.0	16.0	Q1
DS90UB926QSQX/NOPB	WQFN	NKB	60	2000	330.0	16.4	9.3	9.3	1.3	12.0	16.0	Q1

**TAPE AND REEL BOX DIMENSIONS**


\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
DS90UB926QSQ/NOPB	WQFN	NKB	60	1000	853.0	449.0	35.0
DS90UB926QSQE/NOPB	WQFN	NKB	60	250	208.0	191.0	35.0
DS90UB926QSQX/NOPB	WQFN	NKB	60	2000	853.0	449.0	35.0

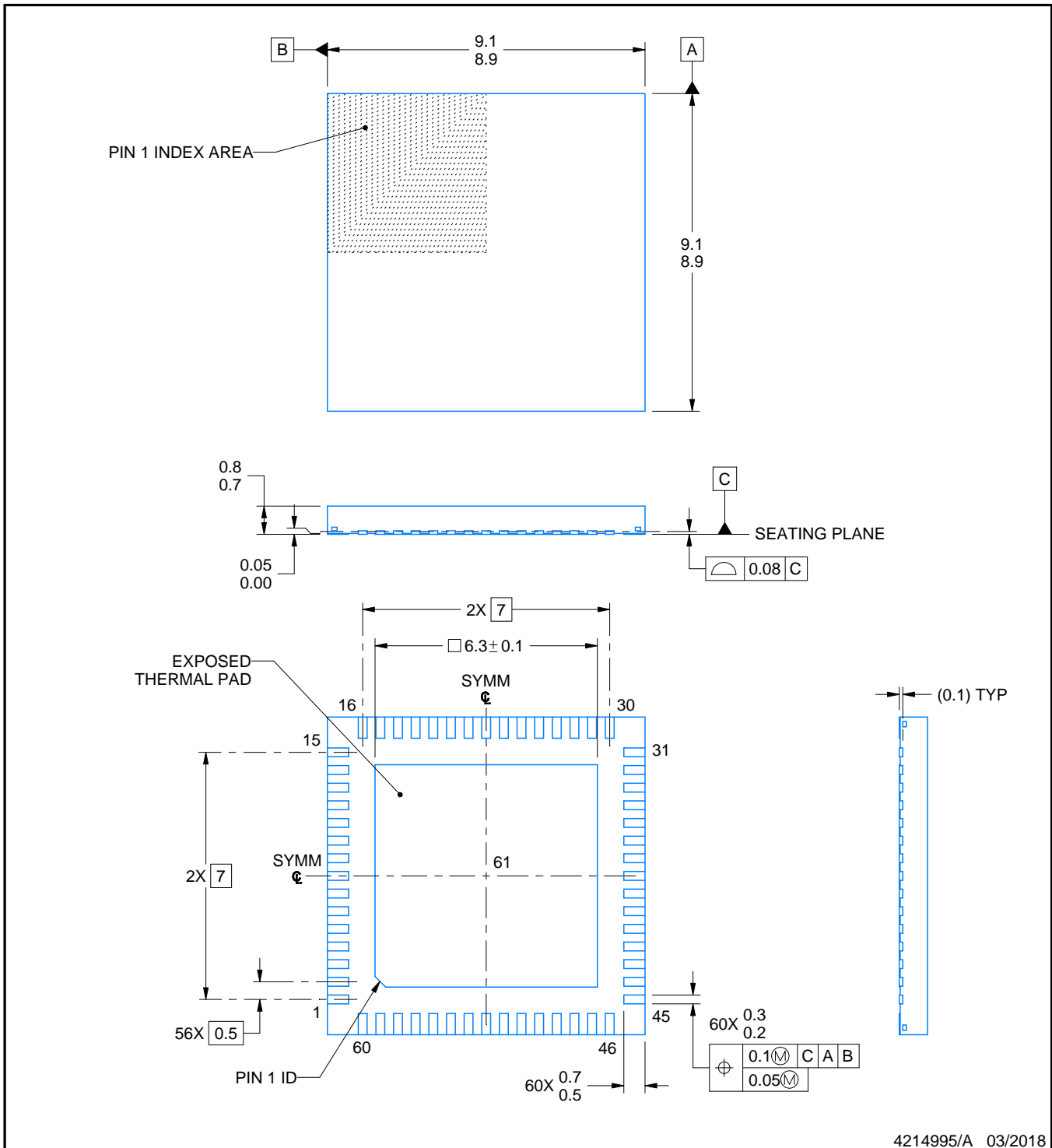
# NKB0060B



# PACKAGE OUTLINE

VQFN - 0.8 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



**NOTES:**

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.

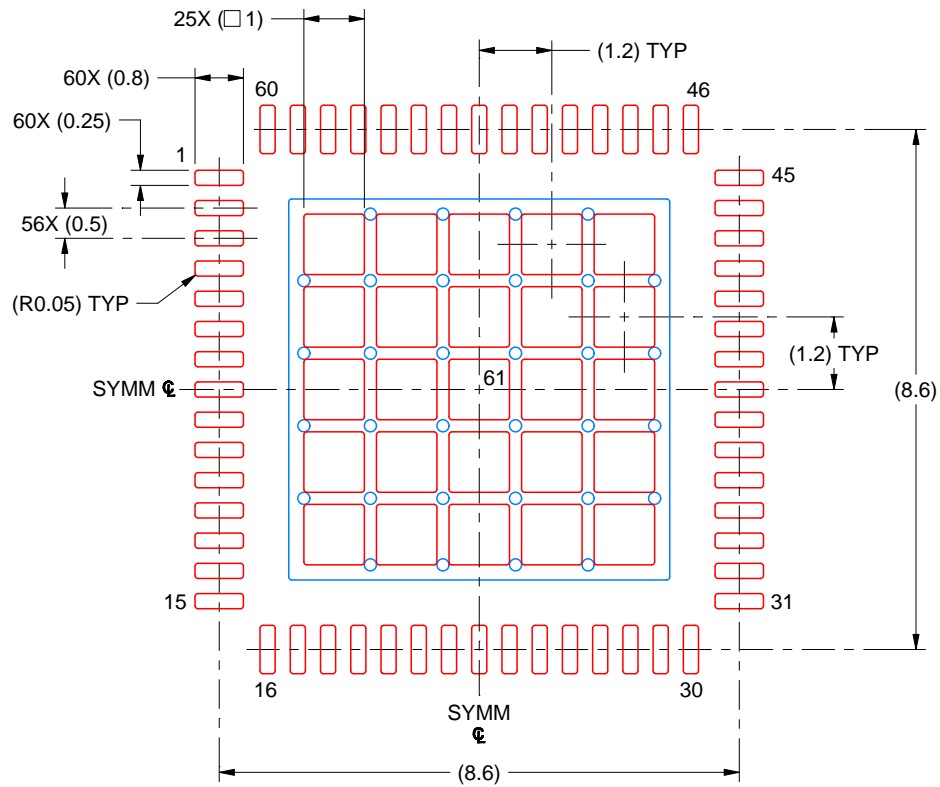


# EXAMPLE STENCIL DESIGN

NKB0060B

VQFN - 0.8 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



SOLDER PASTE EXAMPLE  
BASED ON 0.125 MM THICK STENCIL  
SCALE: 8X

EXPOSED PAD 61  
63% PRINTED SOLDER COVERAGE BY AREA UNDER PACKAGE

4214995/A 03/2018

NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

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